

# ***Thin-film Cathode Fabrication and Characterization***

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**SECA Review**

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*RDS-NETL : Briggs White and Wayne Surdoval*

# Acknowledgements

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Lane Wilson and Chris Johnson  
*National Energy Technology Laboratory, Morgantown WV and Pittsburgh, PA*

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*Department of Chemistry, University of Nevada Las Vegas*

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*Materials Science Division, Argonne National Laboratory, Argonne, Illinois*

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## *Outline*

- Microstructural Characterization
  - Activity / Stability Issues
  - Oxygen Reduction Reaction
- Cathode Surface Fabrication / Characterization
  - Thin Film Geometry Synthesis
  - Combined Thin Film Property Measurements
- Electrical Conductivity Relaxation on LSM
  - Film Structures and Properties vs Bul
  - Orientation Dependence of oxygen uptake
  - Temperature Dependence of oxygen uptake
  - Substrate Dependence of oxygen uptake

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# Solid Oxide Fuel Cells

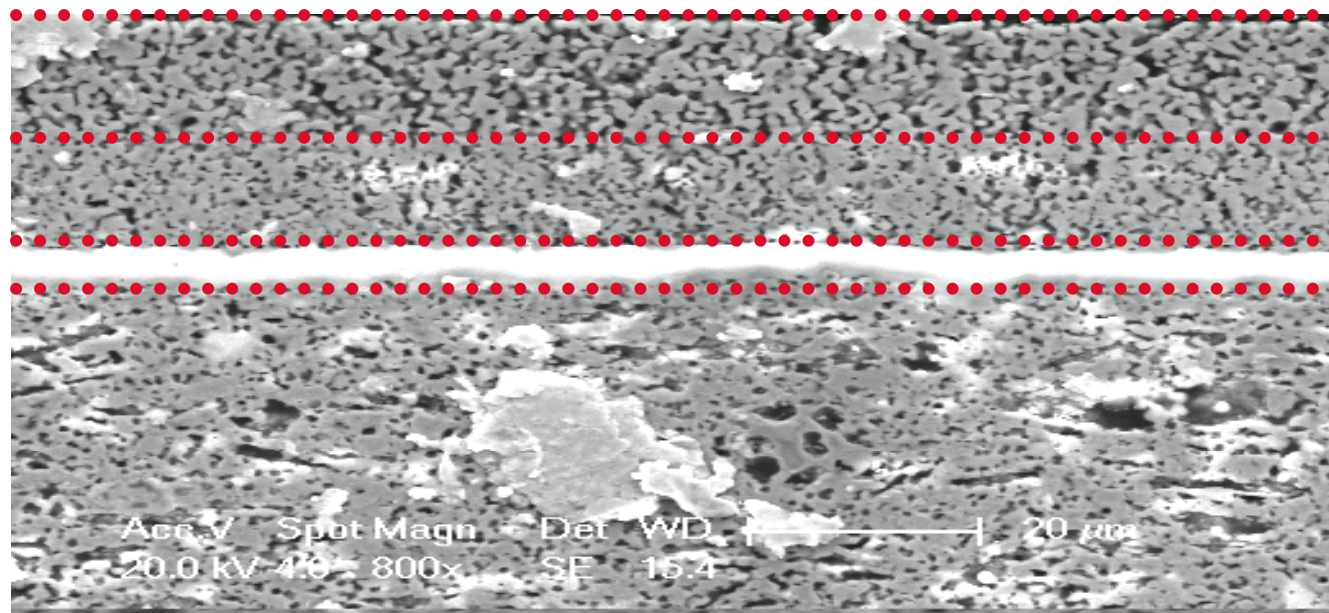
- Performance of SOFCs depend on microstructure of electrochemically active regions
  - three-phase composite*
  - each interpenetrating 3D-connected*
  - electrochemical reaction occurs at or near triple points*

Current Collector  
Pores + (La,Sr)MnO<sub>3</sub>

Active Cathode  
P + LSM + YSZ

Electrolyte (YSZ)

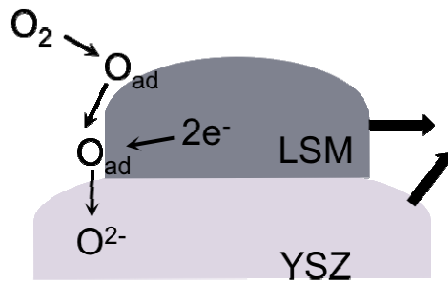
Anode  
P + YSZ + Ni



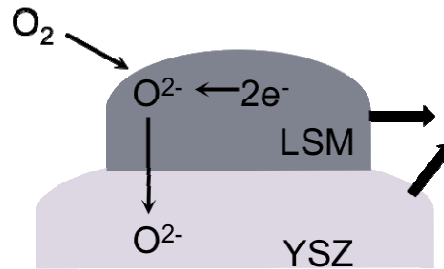
SEM from CMU of NETL prepared SOFC

R. Petrova, Y. Cao, S. Seetharaman, G. Rohrer, P. Salvador, R. Gemman, C. Johnson, L. Wilson

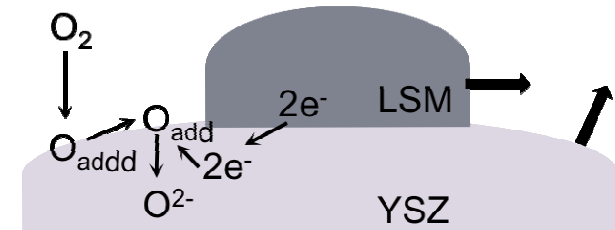
# Oxygen Reduction Reaction



**LSM Surface Path**



**LSM Bulk Path**



**YSZ Surface Path**

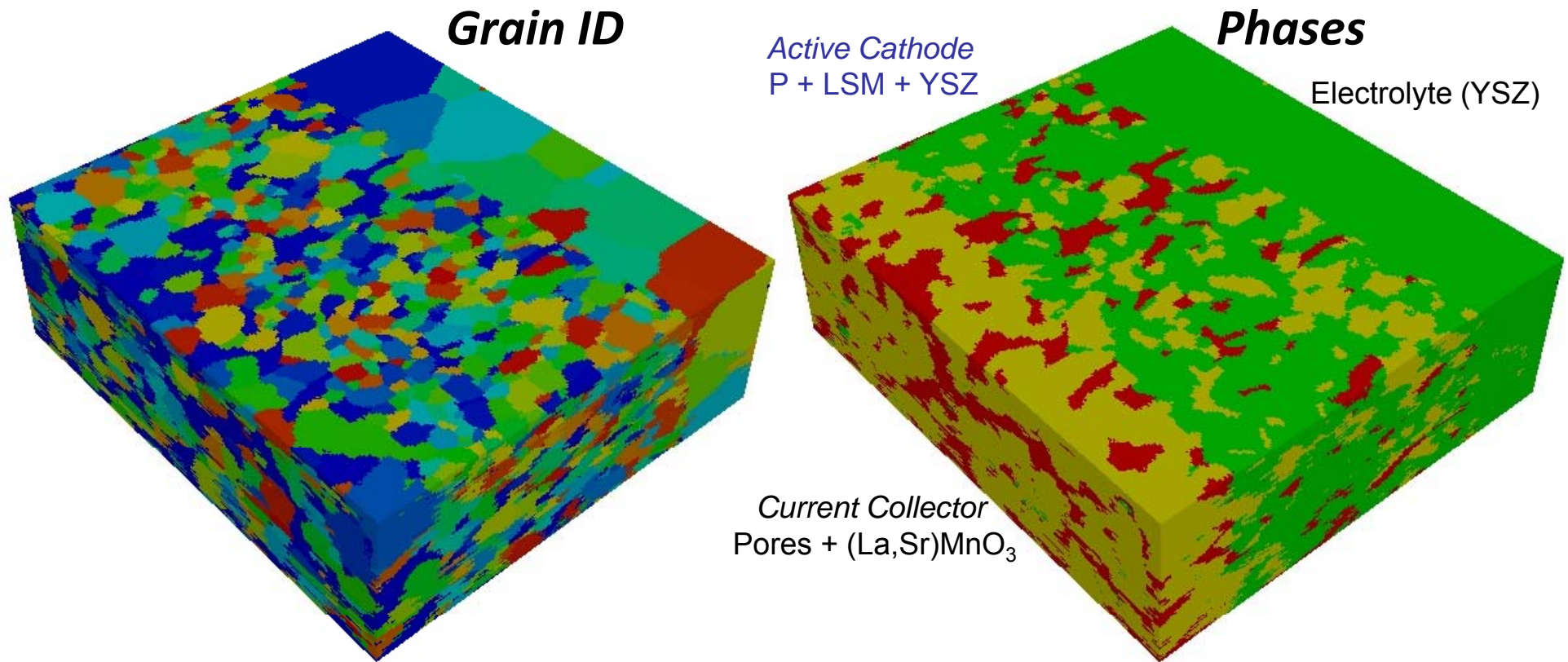
- **Surface Processes**
  - Adsorption
  - Electron Transfer
  - Incorporation

- **Bulk Processes**
  - Electron Transport
  - Ion Transport
  - Long Term Stability

*Can we understand / engineer highly-active and stable surfaces?*

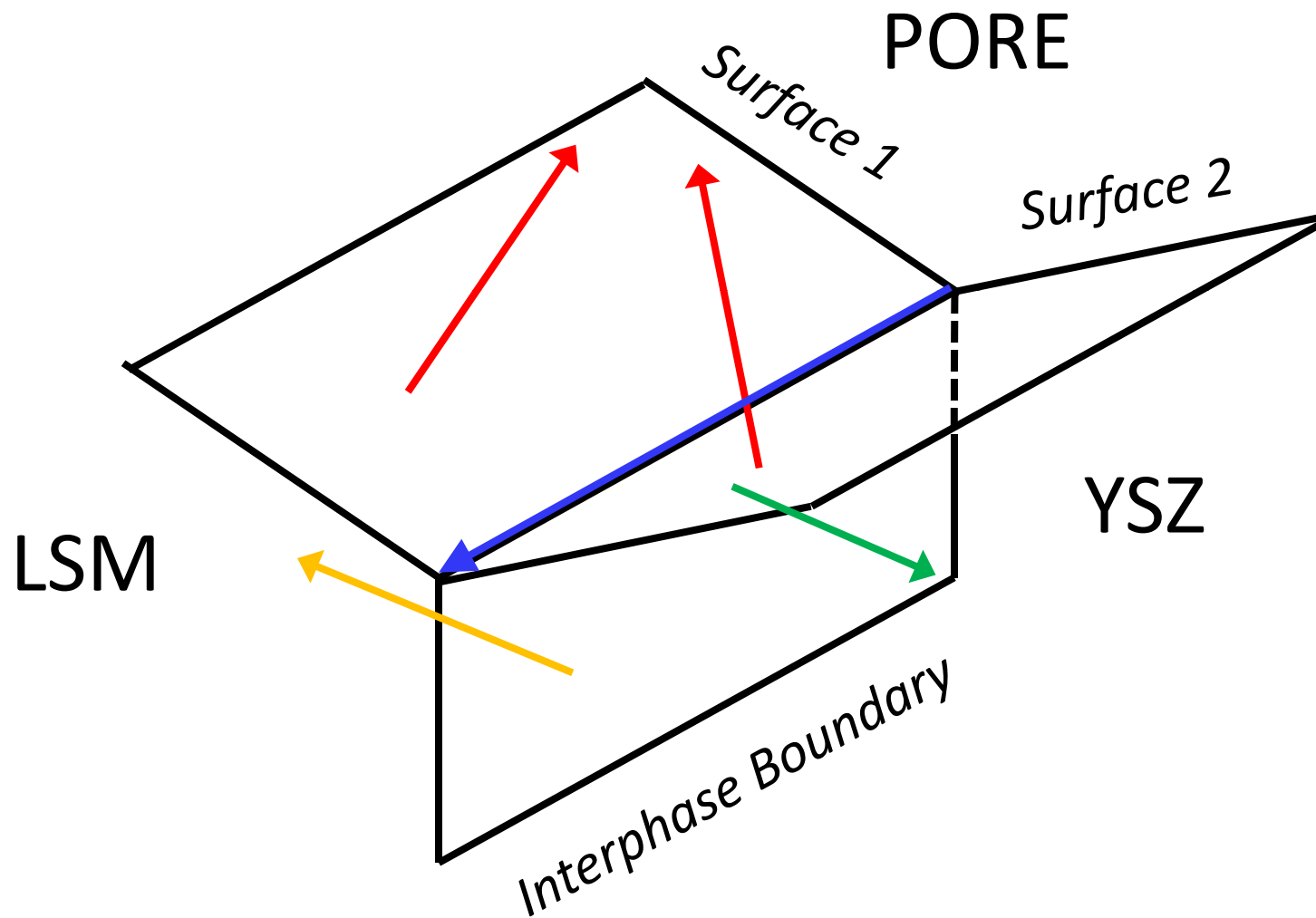
# ***Solid Oxide Fuel Cell Microstructure***

FIB with scanning electron microscope (SEM) and  
electron backscattered detector (EBSD)  
to acquire crystallographic orientation data in 3D

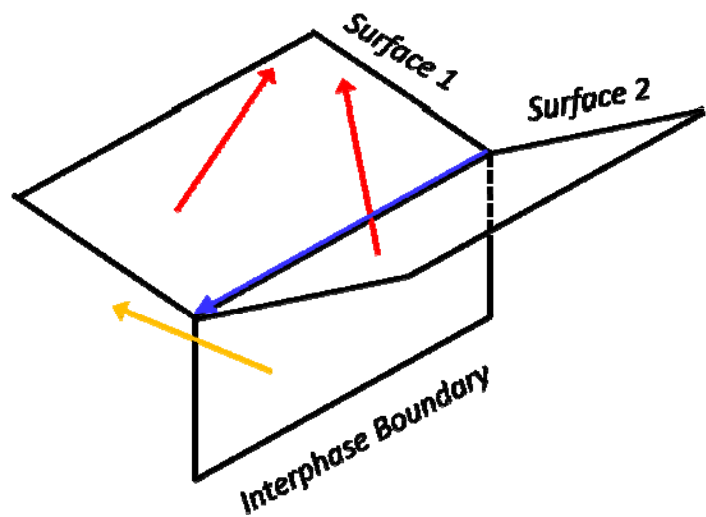


3D OIM from CMU of NETL prepared SOFC  
S. Dillon, L. Helmick, G. Rohrer, P. Salvador, R. Gemman, C. Johnson, L. Wilson

# ***Definitions near triple phase boundary***



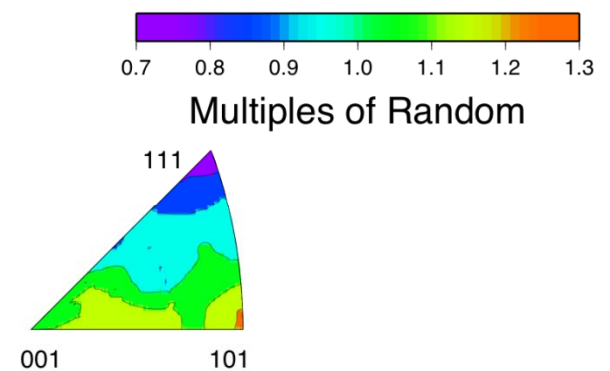
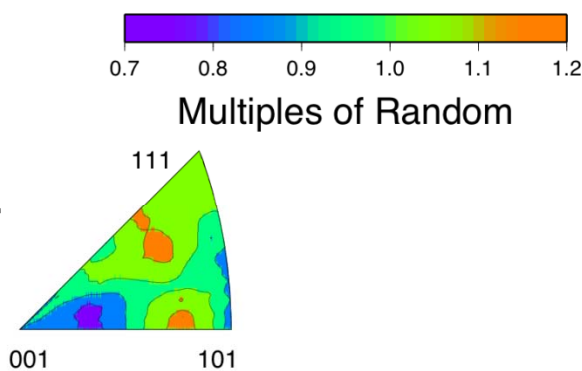
# What kind of surfaces ARE present?



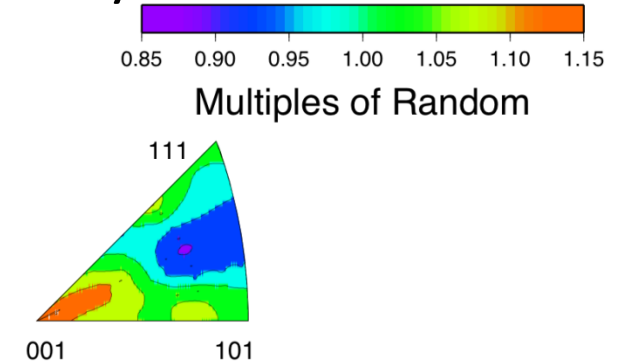
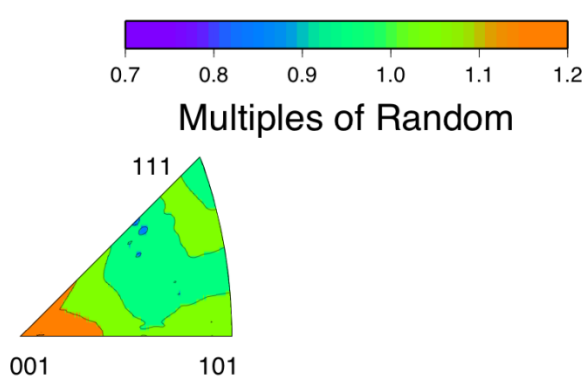
YSZ

LSM

As-received

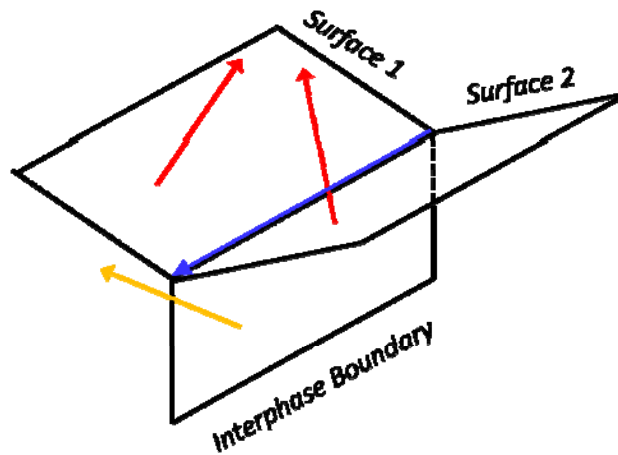


Electrochemically Loaded

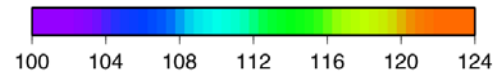


3D Analysis from CMU of NETL prepared SOFC  
S. Dillon, G. Rohrer, P. Salvador, R. Gemman

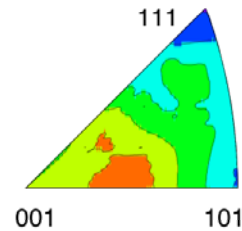
# Why are those kinds of surfaces ARE present?



YSZ

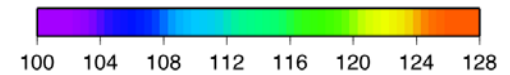


Multiples of Random

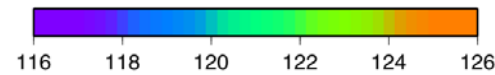
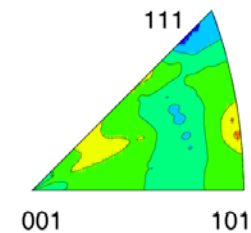


As-received

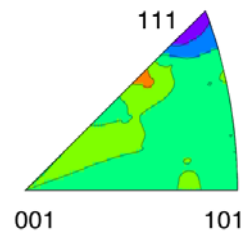
LSM



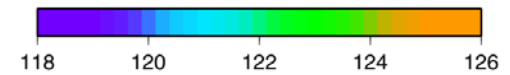
Multiples of Random



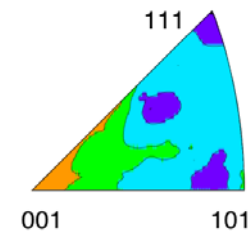
Multiples of Random



Electrochemically Loaded



Multiples of Random

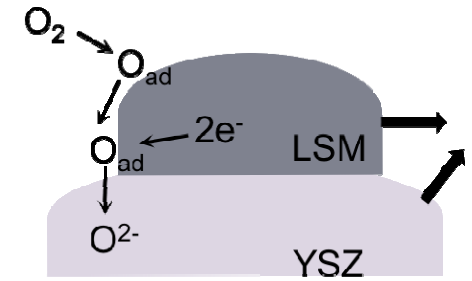




# Solid Oxide Fuel Cell Microstructure

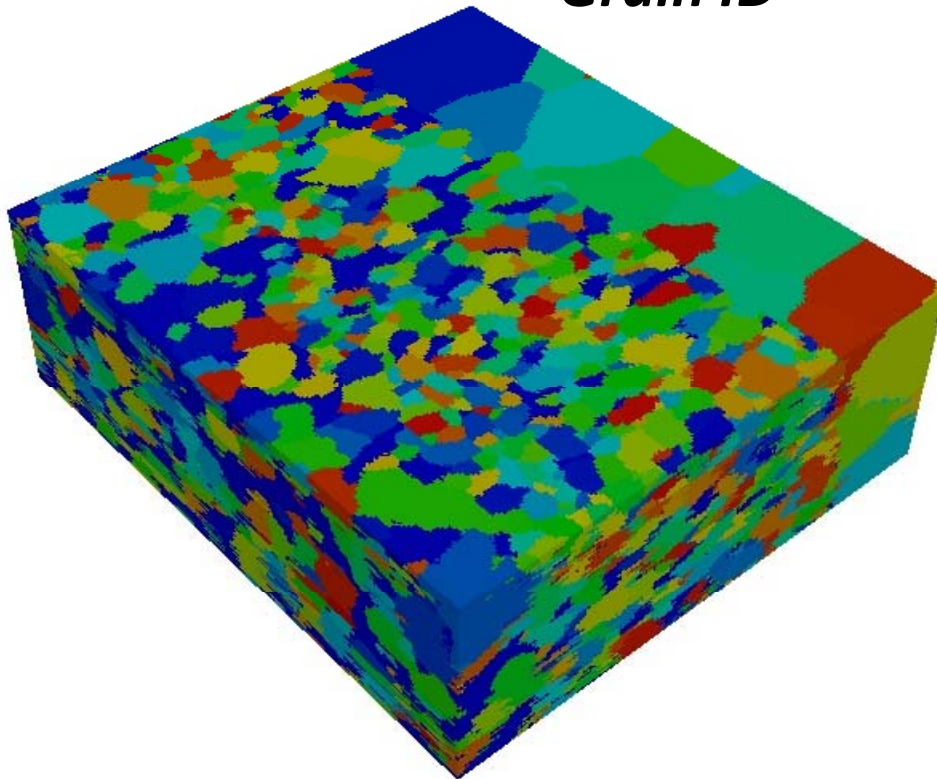
Can Map Crystallography AND Microstructures  
in Complex Systems !

What are the local CONDITIONS and local Properties?



**LSM Surface Path**

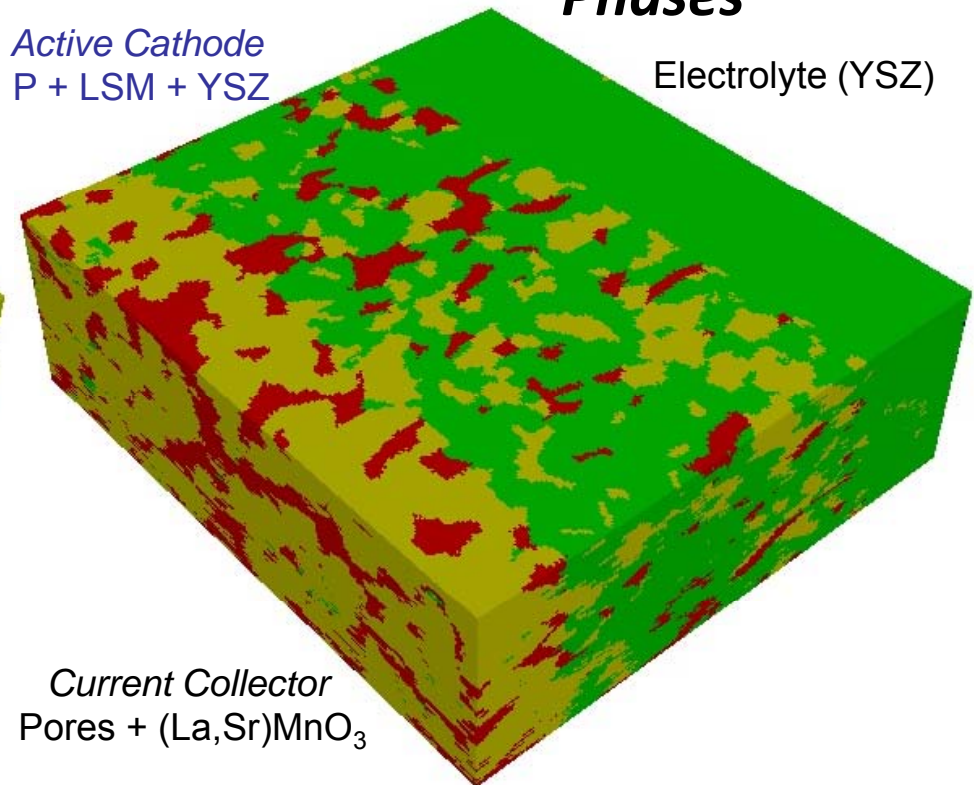
**Grain ID**



**Phases**

Active Cathode  
P + LSM + YSZ

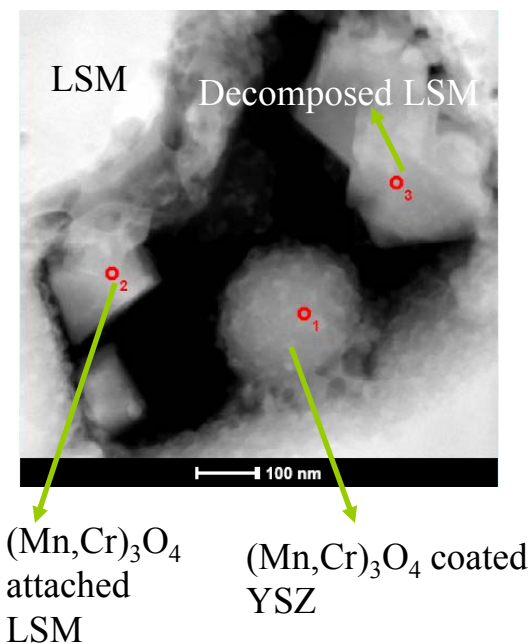
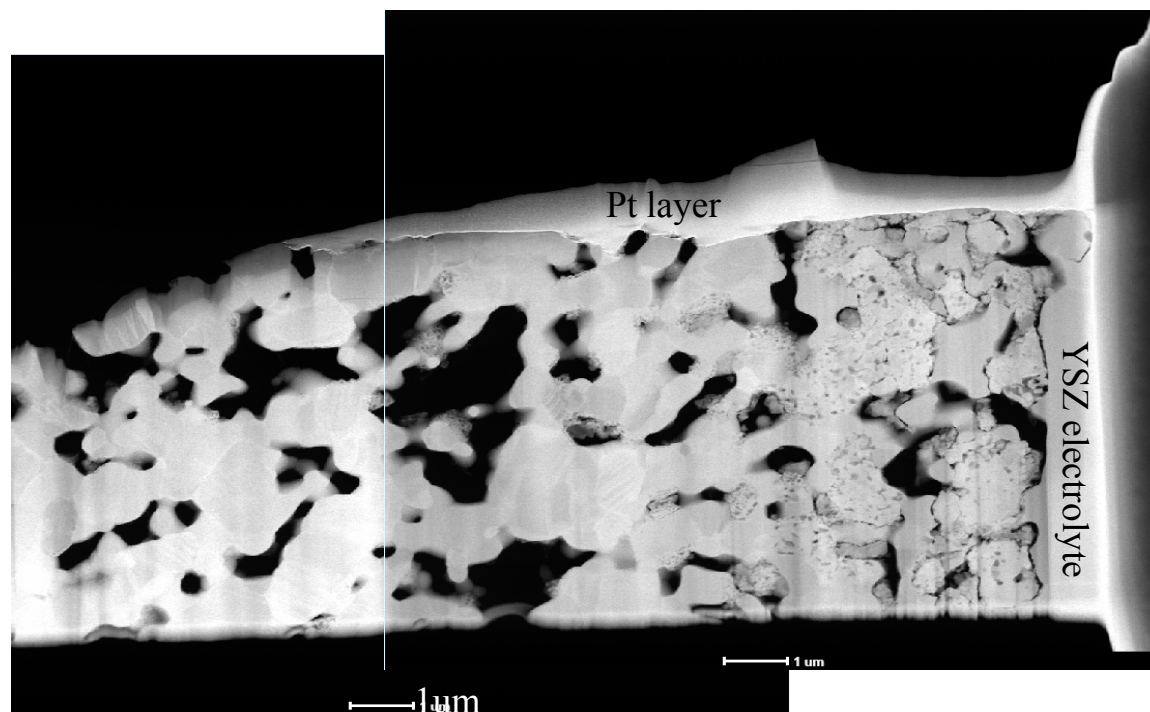
Electrolyte (YSZ)



Current Collector  
Pores + (La,Sr)MnO<sub>3</sub>

# TEM Study of Degradation

□ 700°C, E-brite, 2.3 A, 380%  $\Delta V$ /10000hr, channel



TEM from CMU of ANL prepared SOFCs

S. Wang, P. Salvador, T. Cruse, B. Ingram, M. Krumpelt

Microstructure Degradation is Related to  
Electrochemical Reaction of Chromium Vapors that is Spatially Varying

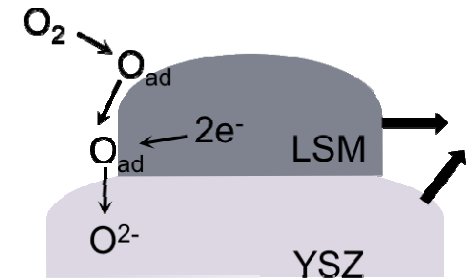
Cruse, T. A.; Krumpelt, M.; Ingram, B.; Wang, S.; Salvador, P. A.

In TMS 2008 Annual Meeting Proceedings Volume 1: Materials Processing and Properties, 2008; pp 571-580.



# ***Solid Oxide Fuel Cell Microstructure***

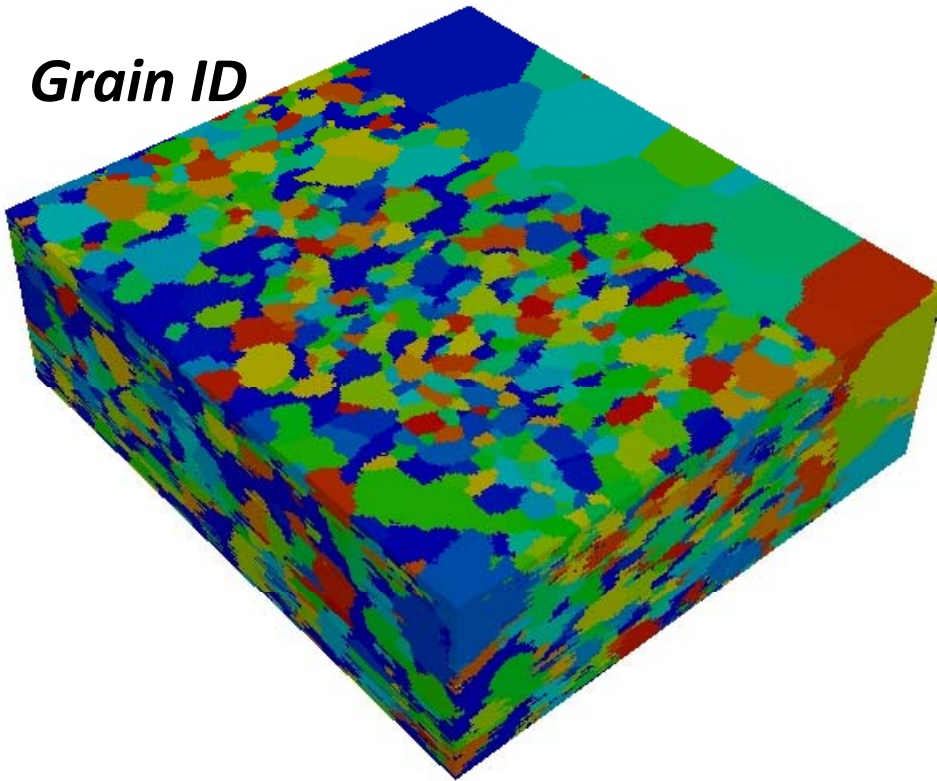
Long Term Basic Science Goal to  
Predict/Model Performance using  
Structural and Material Parameters!



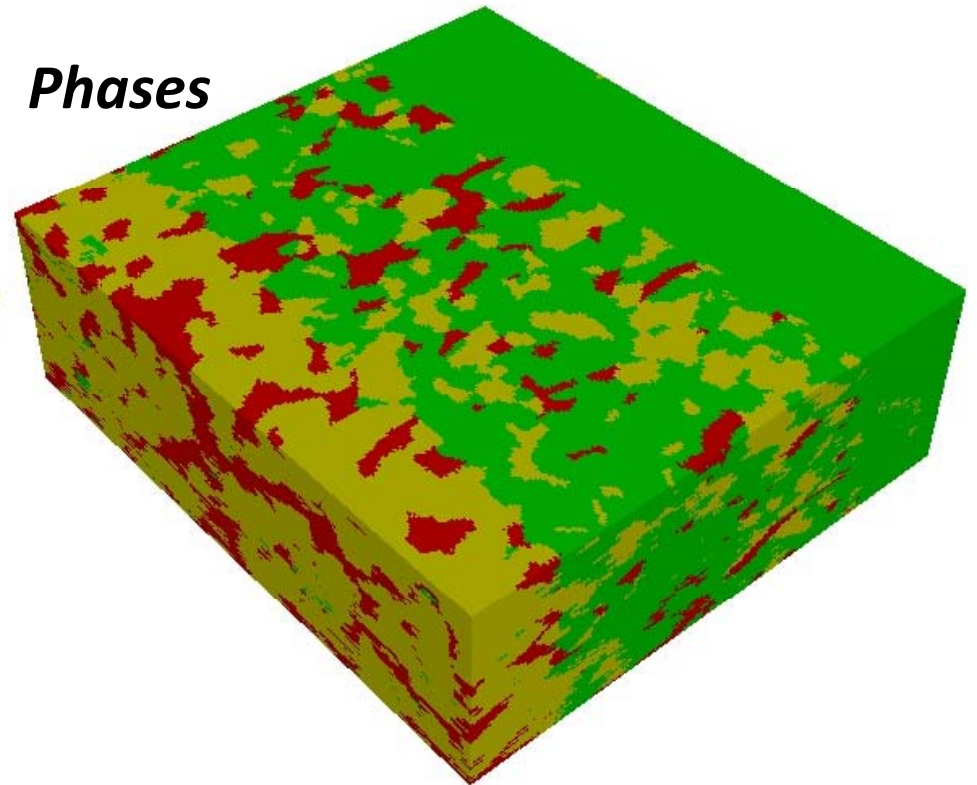
**LSM Surface Path**

What are the surface related materials parameters?

***Grain ID***

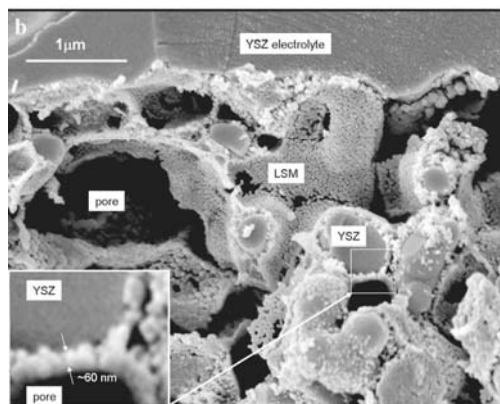
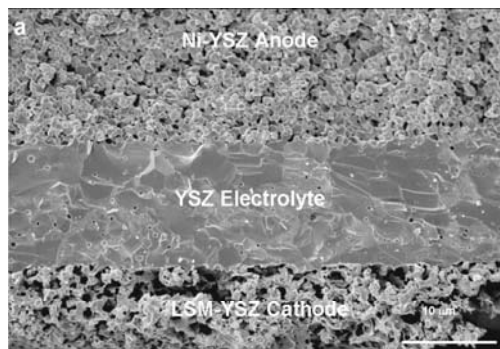


***Phases***

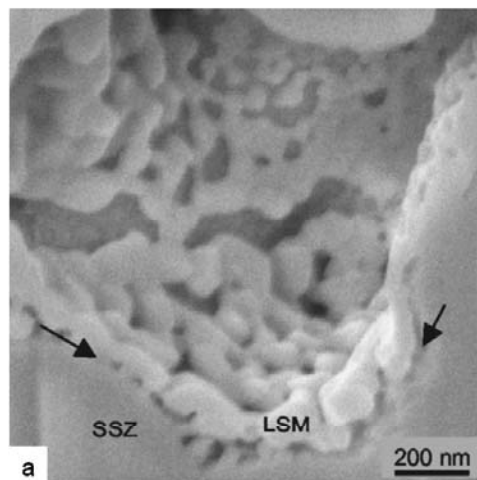


# Nanoparticles can be used in Extreme Conditions

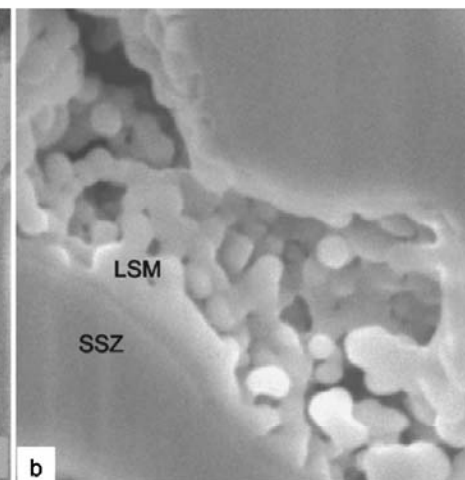
*As-synthesized LSM nanoparticles in SOFC*



*As-synthesized LSM nanoparticles on SSZ*



*Annealed at 650 for 500h at 150 m/cm<sup>2</sup>*



Scholklapper et al. (LBL),  
*Electrochem. Solid-State Lett.*, **10**, B74 (2007)

Scholklapper et al. (LBL),  
*Electrochem. Solid-State Lett.*, **9**, A376 (2006)

*What are the ideal materials to use as backbone or infiltrate?*

*How does high temperature electro-catalysis occur?*

*What is the stability of materials in extreme conditions?*

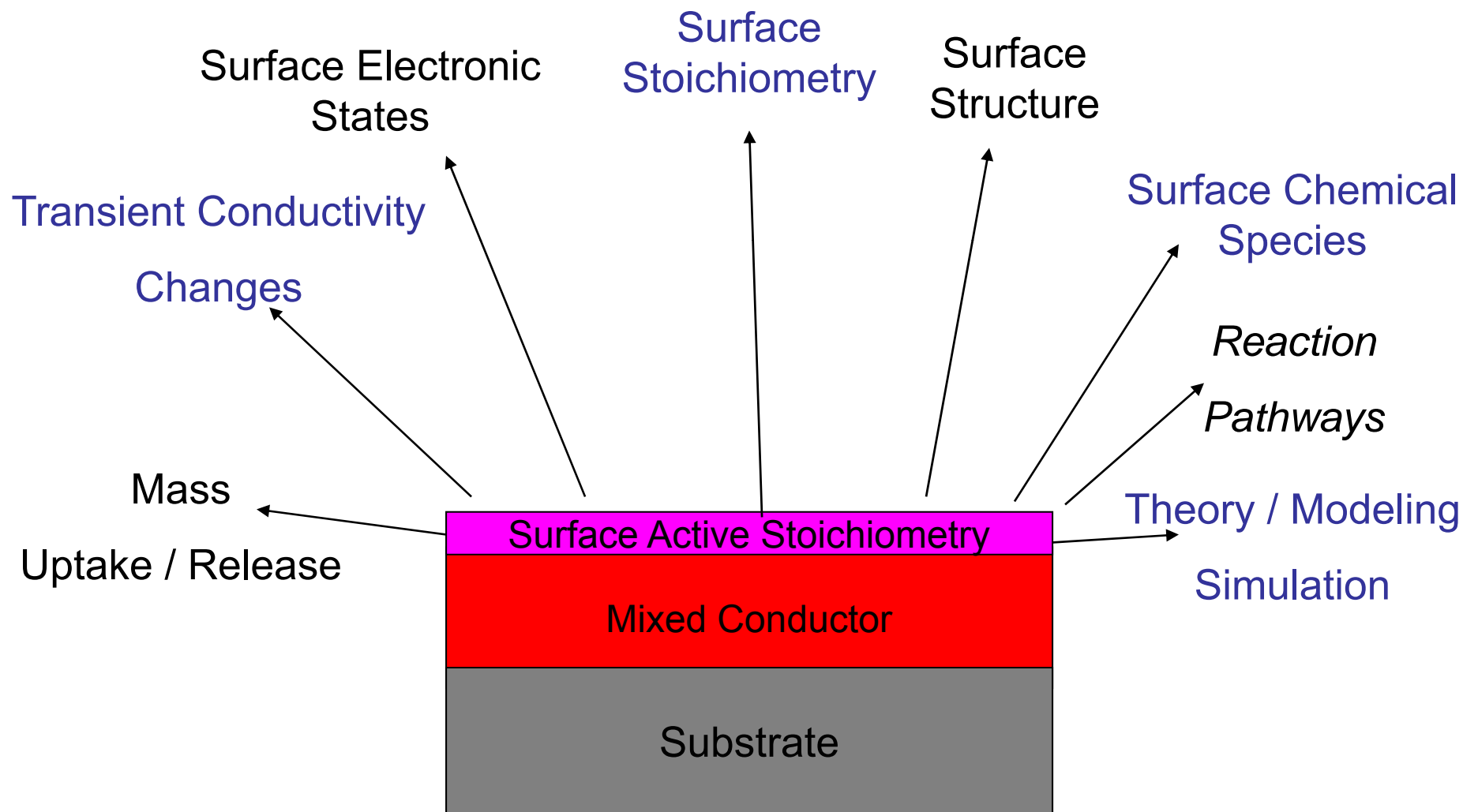
*How does the surface chemistry / electronic structure change in operation?*

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# Building a Team to Understand Oxygen Reduction: Thin Films Samples with “controlled” Surfaces

*Probe the nature of atomic scale surface chemistry or interface crystallography rather than the device scale micro-structural perturbations.*

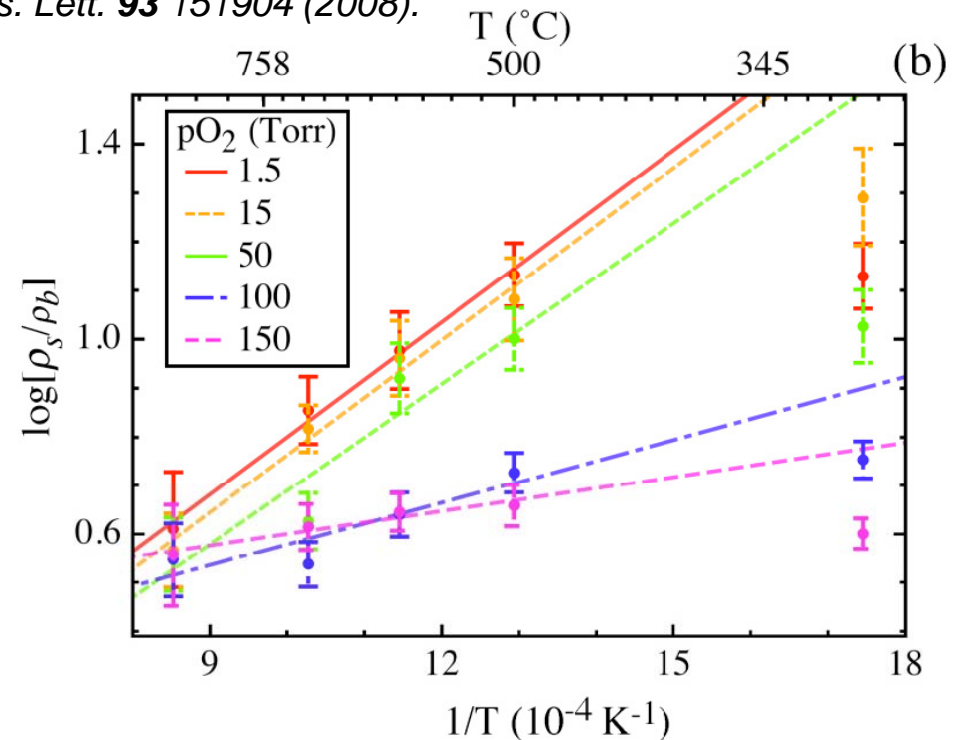
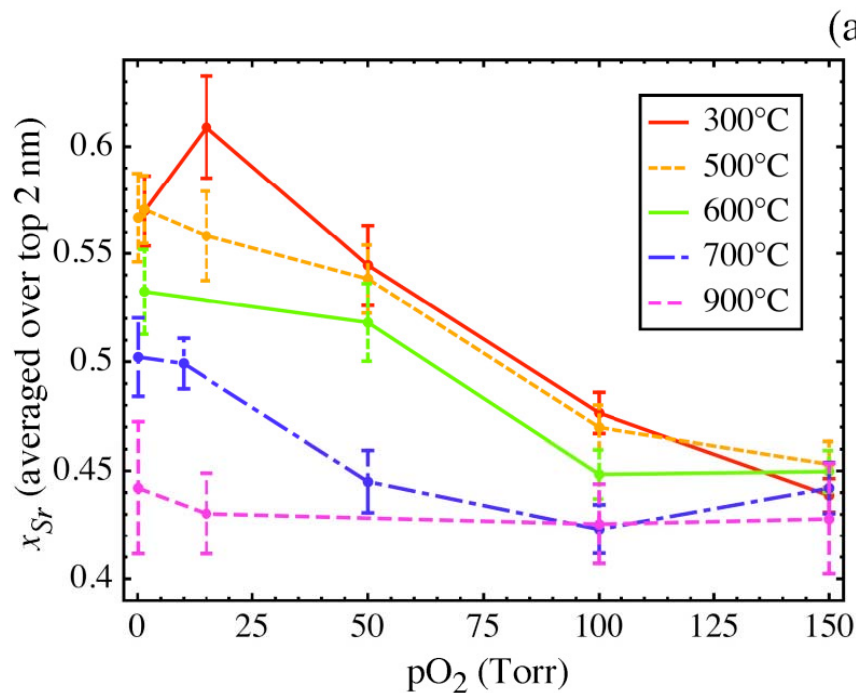


*Concepts partially developed by L. Wilson and P. A. Salvador*

# Strontium Segregation vs T and P for LSM Films on Perovskite Substrates

16 nm LSMO on DyScO<sub>3</sub>,  
700°C, pO<sub>2</sub> = 150 Torr

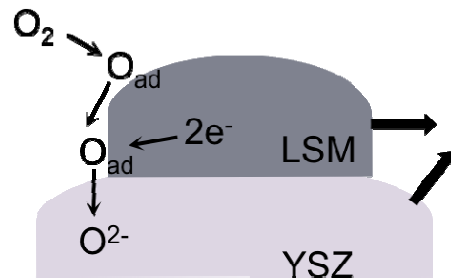
Fister et al., Appl. Phys. Lett. **93** 151904 (2008).



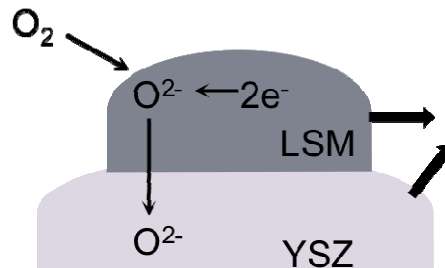
- **Observe that Sr segregation depends on both T and pO<sub>2</sub>**
  - plot shows average Sr composition in ~3 nm surface region (bulk composition = 0.3)
  - Enthalpy of segregation  $\approx < .1 \text{ eV / atom}$  and is pO<sub>2</sub> dependent.



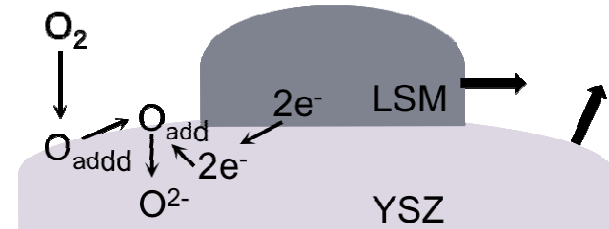
# What happens during oxygen uptake?



**LSM Surface Path**



**LSM Bulk Path**



**YSZ Surface Path**

- **Adsorption**

- *Mass of Material* (Gravimetry)
- *Surface Chemistry* (Spectroscopy)
- *Surface Electronic Structure* (Kelvin Probe, STS, Normal Conductivity)

- **Electronic transfer**

- *Consumption of holes* (Parallel Conductivity / Thermopower)
- *Fermi Level Changes* (Kelvin Probe / STS)
- *Surface chemistry* (Spectroscopy)

- **Oxygen Vacancy Consumption**

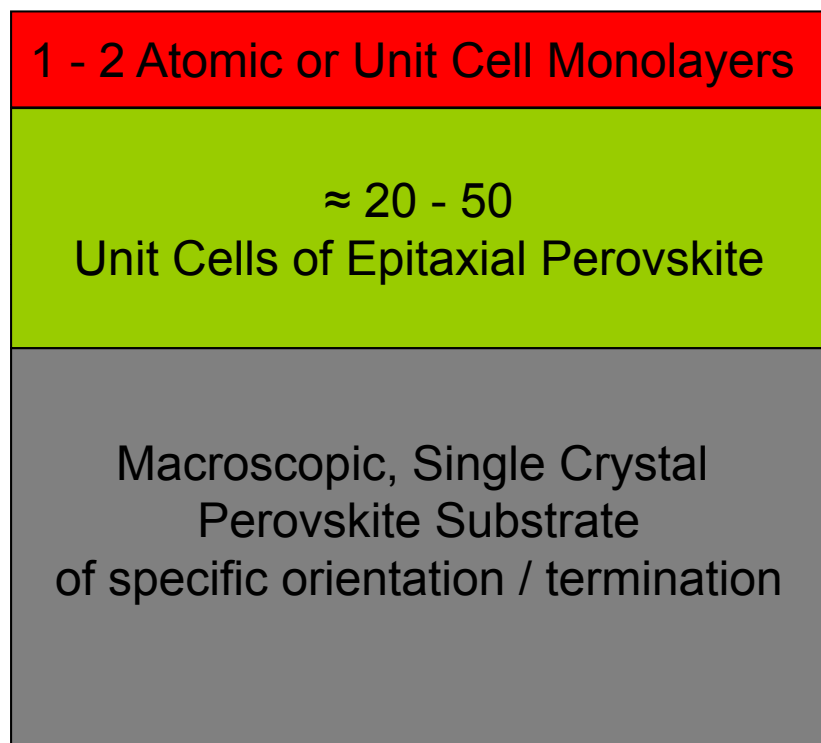
- *Mass Change* (Gravimetry)
- *Total charge density* (Conductivity / Thermopower)
- *Surface Chemistry* (Spectroscopy)

# CMU Work for Cathode Surface Science Project

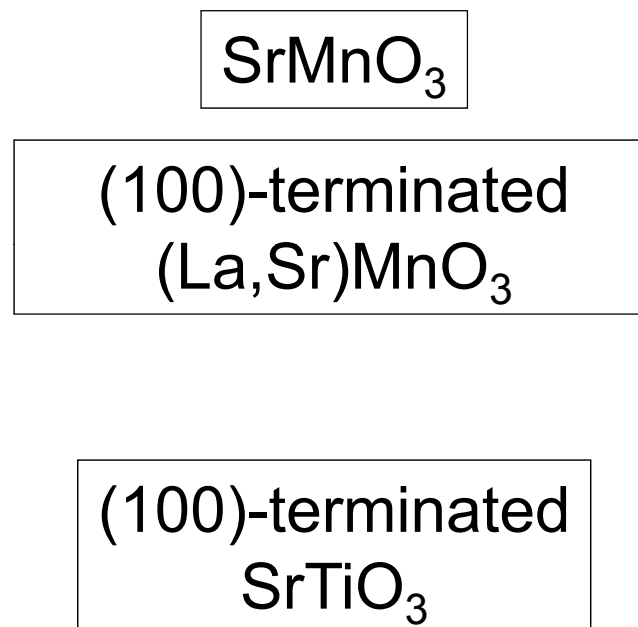
- ***Growth of High-Quality Thin Film Samples***
  - *Perovskite / Perovskite Epitaxy and Surface Control*
  - *Perovskite / Fluorite Epitaxy and Surface Control*
  - *Generation of Surface-Modified Samples*
- ***Surface Kinetics for Oxygen Uptake***
  - *Electrical Conductivity Relaxation*
  - *Piezoelectric Crystal Microbalance Gravimetry*
  - *Kelvin Probe Spectroscopy*
- *Surface Thermodynamics of Oxygen Uptake*
  - *Piezoelectric Crystal Microbalance Gravimetry*
  - *Kelvin Probe Spectroscopy*
- *Electronic Structure*
  - *Kelvin Probe Spectroscopy*
  - *STM (MIT)*
- *Ex-situ Surface Characterization for Correlations*
  - *Scanning Auger / XPS*

# ***“Ideal” Surface Science Sample***

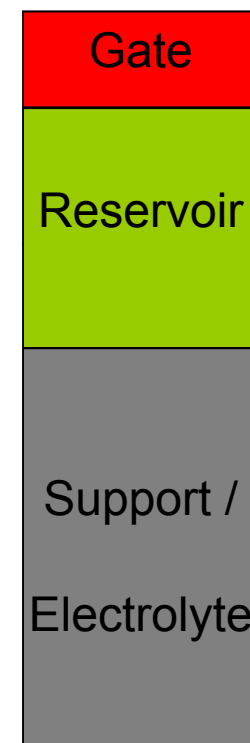
## **General Schematic**



## **Example**



## **Concept**



*Control Microstructural Complexity and Surface Crystallography*

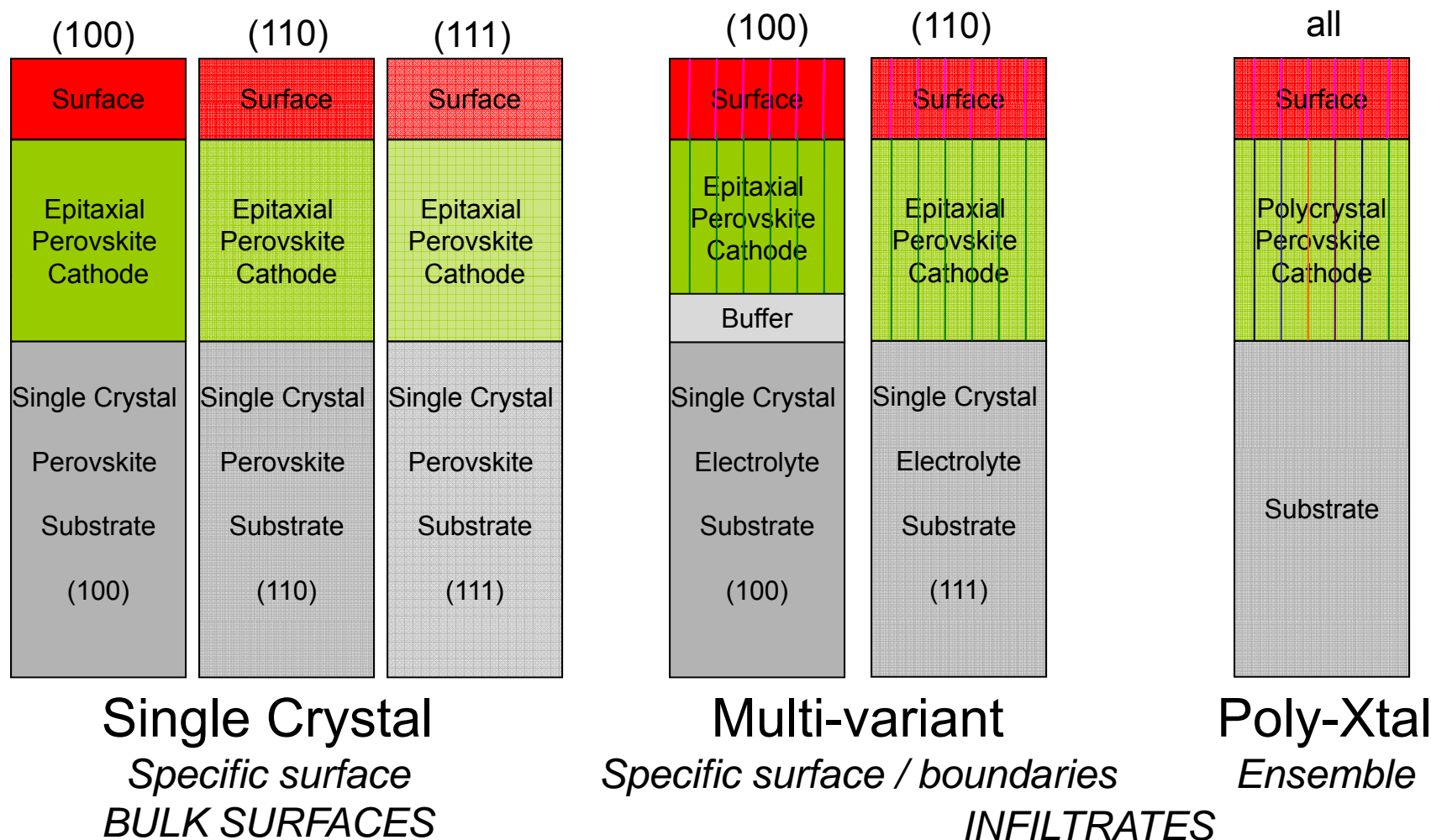


# Summary of Sample Preparation

- *Growth of High-Quality Thin Films*
  - *Perovskite / Perovskite Epitaxy and Surface Control Achieved*
    - *LSM and LSC and LSCF (and LNO) deposited on many Perovskites*
    - *Cube-on-cube epitaxy on various orientations*
    - *Unit-cell roughness obtained*
  - *Perovskite / Fluorite Epitaxy and Surface Control Achieved*
    - *LSM and LSC and LSCF (110)[111] epitaxy on YSZ (111)[[11-2]*
    - *LSM and LSC and LSCF (100)[011]epitaxy on GDC-YSZ (100)[010]*
    - *Unit-cell roughness obtained*
    - *6 and 4 variants observed on (111) and (100) fluorites*
- *Samples Provided to Collaborators*
  - *Measured Surface Chemistry at APS*
  - *Measured Electronic Properties at MIT*
  - *Measured Electronic Properties at UNLV*
  - *Measured Surface Properties at NETL*

# Thin Film Samples Driving Surface Science

Films Allow for Surface / Microstructural Control

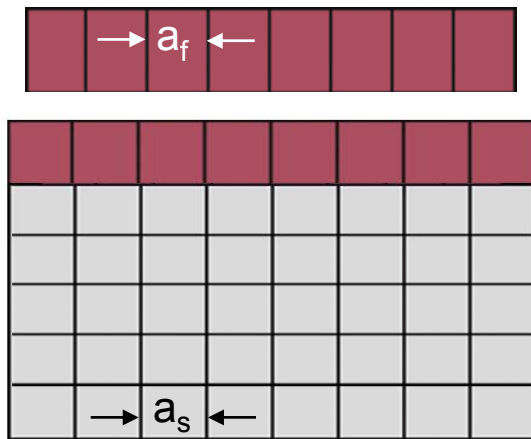


*How do we synthesize these materials?*

# Cathode thin film growth – Substrate choice and orientation

## Mismatch Strain

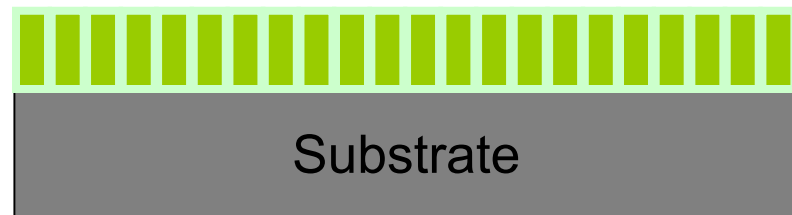
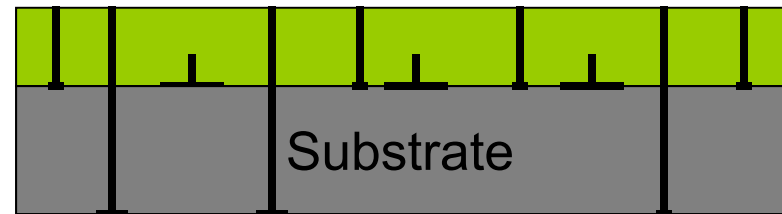
$$f = \frac{(a_s - a_f)}{a_f}$$



$$w_{strain}^{max} = \frac{2\mu(1+\nu)f^2}{(1-\nu)}$$

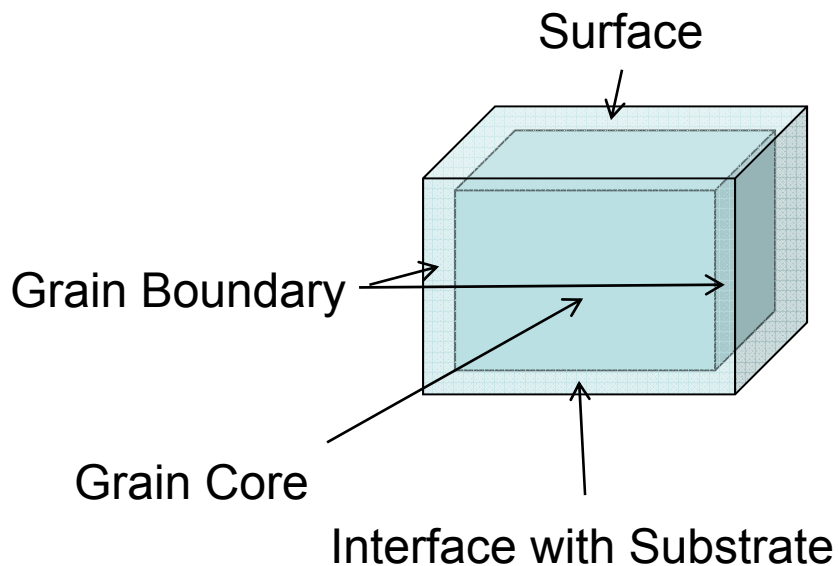
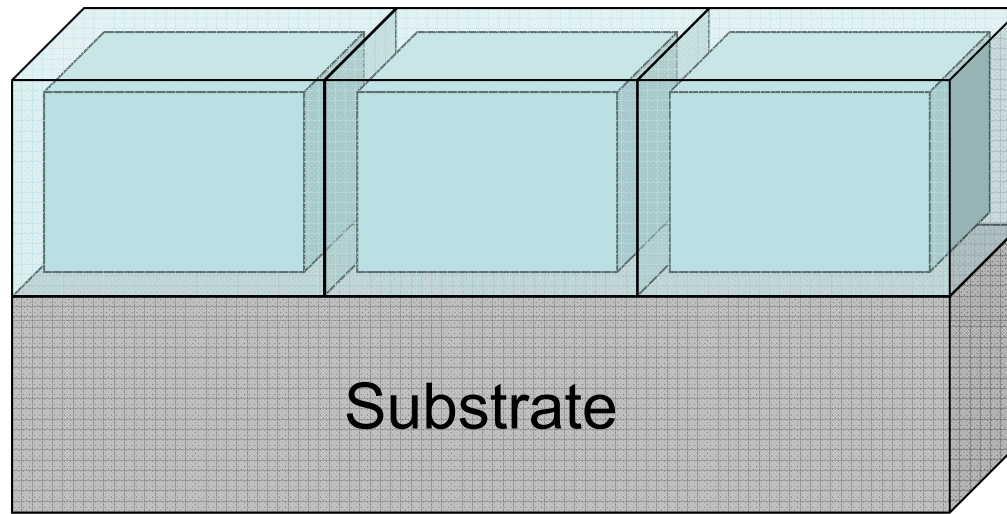
## Dislocations

Misfit  
Threading (relaxation)  
Threading (inherited)



*Substrates have different lattice mismatches and  
Different dislocation densities*

# Brick-Layer Type Model of Interaction



*All Films have some level of Defects*

*How does the nature of the interfacial features affect performance?*

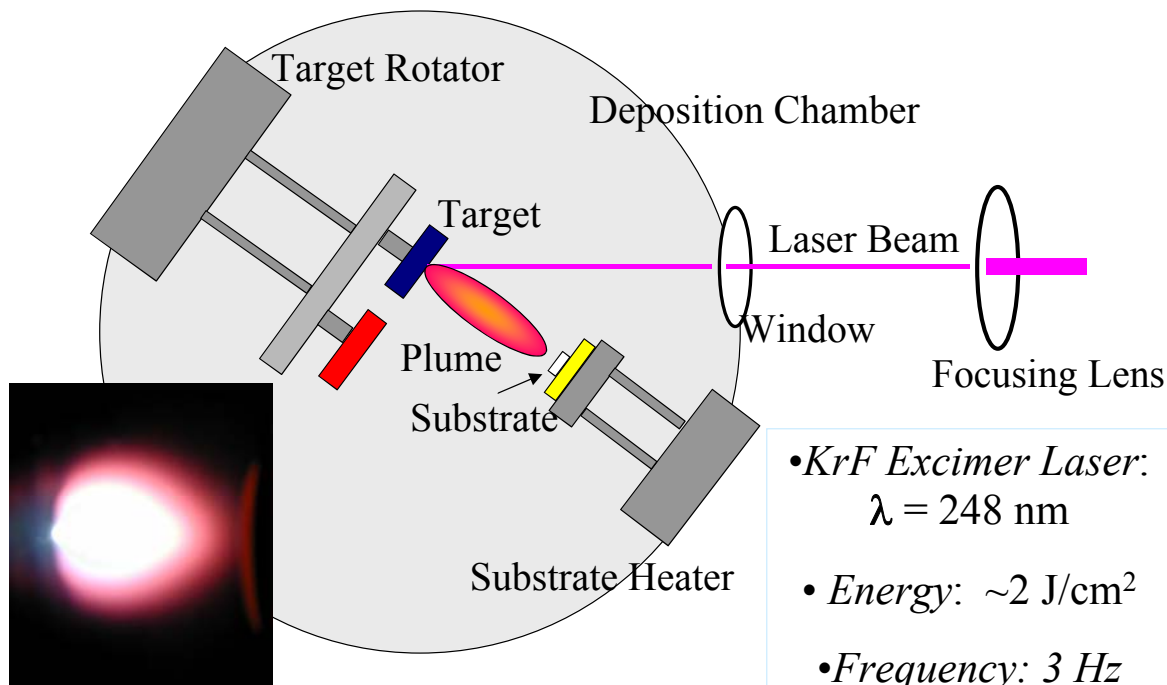
*Surface  
Grain Boundary  
Interface*

# Pulsed Laser Deposition Laser MBE / MBE

## Advantages of PLD

- Targets made via standard methods.
- Stoichiometric transfer from target to film
- High-quality epitaxial films for complex oxides
- High-Quality Metal Films
- Simple, versatile, and relatively inexpensive
- House 6 targets at once

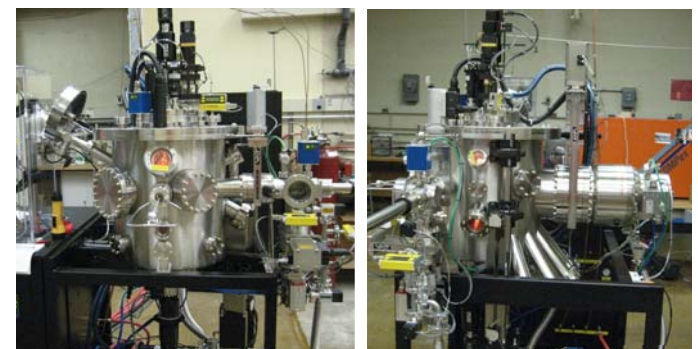
## *Pulsed Laser Deposition*



## Deposition Parameters

PRESSURE : 0.00001 - 0.2 Torr  
TEMPERATURE: RT - 950 °C  
FLUENCE : 1-8 J/cm<sup>2</sup>  
FREQUENCY : 1-10 Hz  
COOLING: 0.00001- 300 Torr

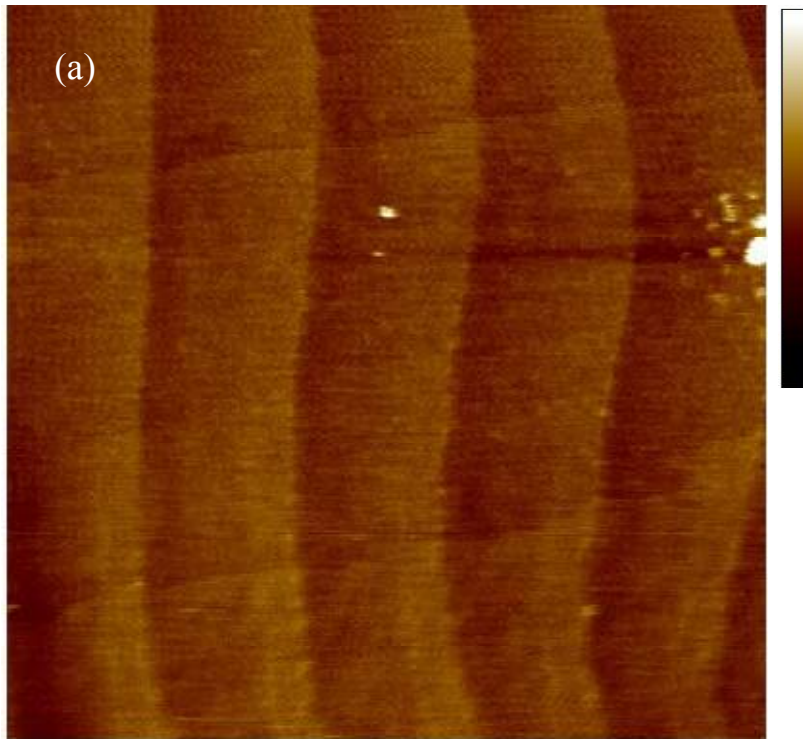
Depositions : 1- 4 hrs Max  
3 - 4 depositions / day  
3 - 4 samples / deposition



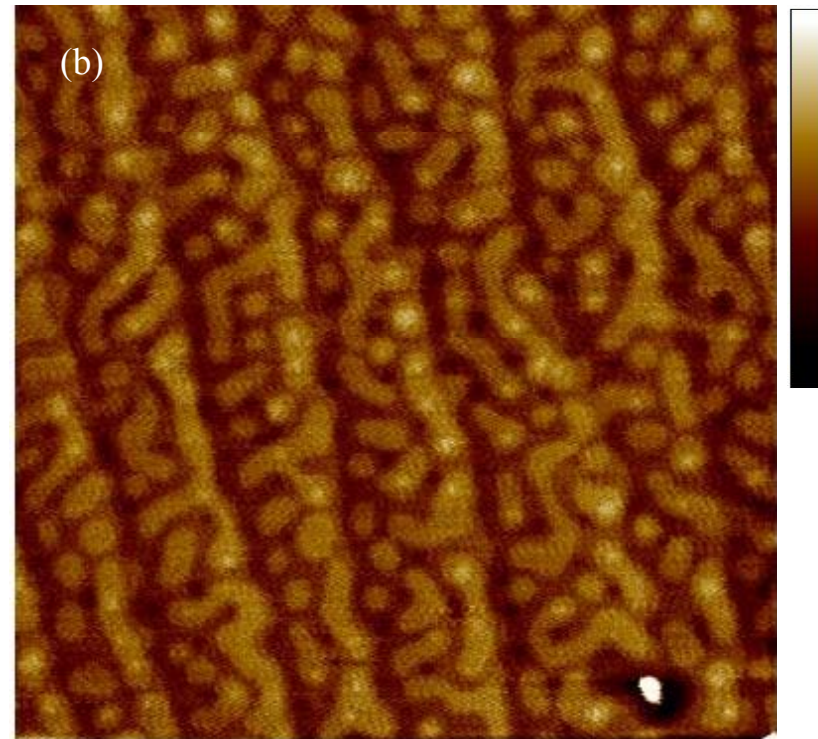
# Surface Engineering

## $\text{SrTiO}_3$ Crystals / $(\text{La,Sr})\text{MnO}_3$ Films

$\text{SrTiO}_3$  Crystals  
 $1 \times 1 \mu\text{m}^2$  (3 nm)  
 $\text{TiO}_2$  Terminated



10.8 nm  $(\text{La,Sr})\text{MnO}_3$  Film  
 $1 \times 1 \mu\text{m}^2$  (3 nm)  
 $\text{MnO}_2$  Terminated ?



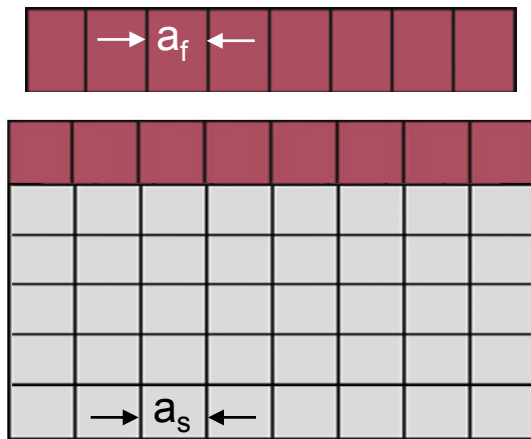
*Atomically smooth surfaces by controlling growth  
minimize microstructure and can be used for STM / STS*



# Cathode thin film growth – Substrate choice and orientation

## Mismatch Strain

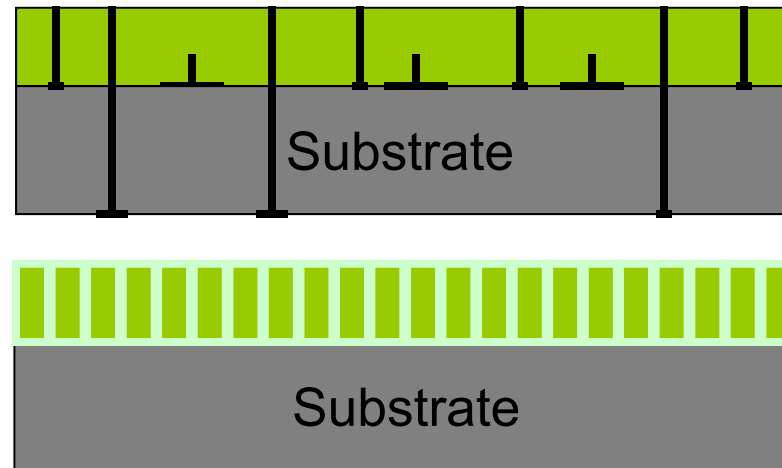
$$f = \frac{(a_s - a_f)}{a_f}$$



$$w_{strain}^{max} = \frac{2\mu(1+\nu)f^2}{(1-\nu)}$$

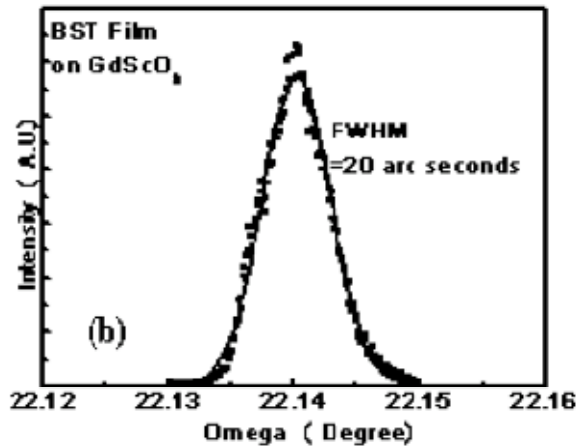
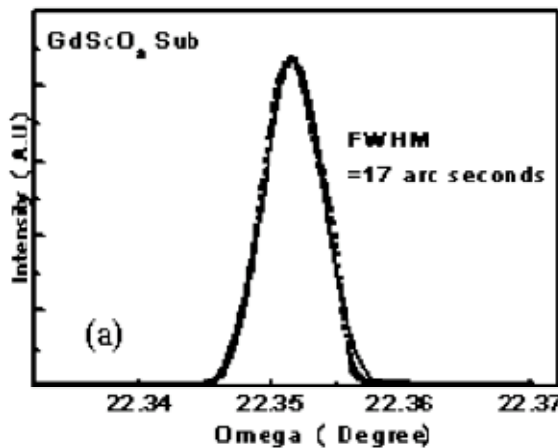
## Dislocations

Misfit  
Threading (relaxation)  
Threading (inherited)

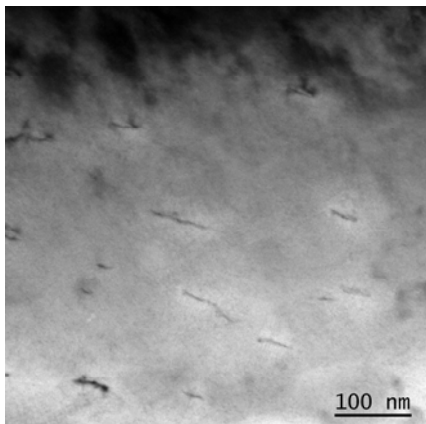


*Substrates have different lattice mismatches and  
Different dislocation densities*

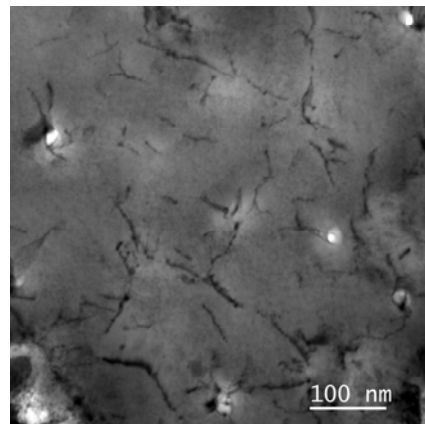
# Film Dislocation Densities: (Ba,Sr)TiO<sub>3</sub> Example



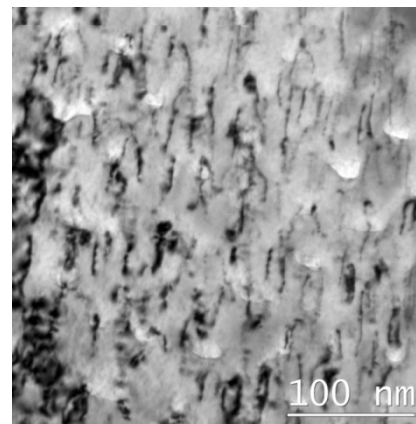
Substrate Material	FWHM of Film Rocking Curve (°)
MgO (100)	0.153
GdScO <sub>3</sub> (110)	0.008
DyScO <sub>3</sub> (110)	0.009
LSAT (100)	0.016
LaAlO <sub>3</sub> (100)	0.183



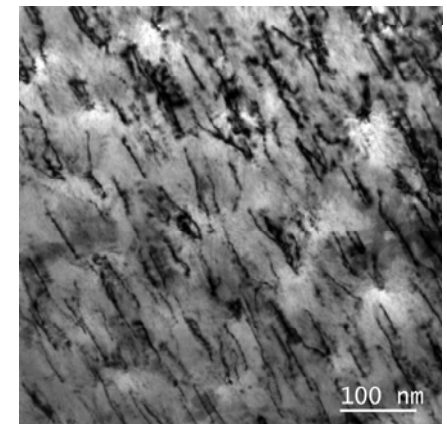
BST/GdScO<sub>3</sub>  
6x10<sup>9</sup>/cm<sup>2</sup>



BST/DyScO<sub>3</sub>(110)  
2x10<sup>10</sup>/cm<sup>2</sup>



BST/LSAT  
2x10<sup>11</sup>/cm<sup>2</sup>



BST/LAO  
2.7x10<sup>11</sup>/cm<sup>2</sup>



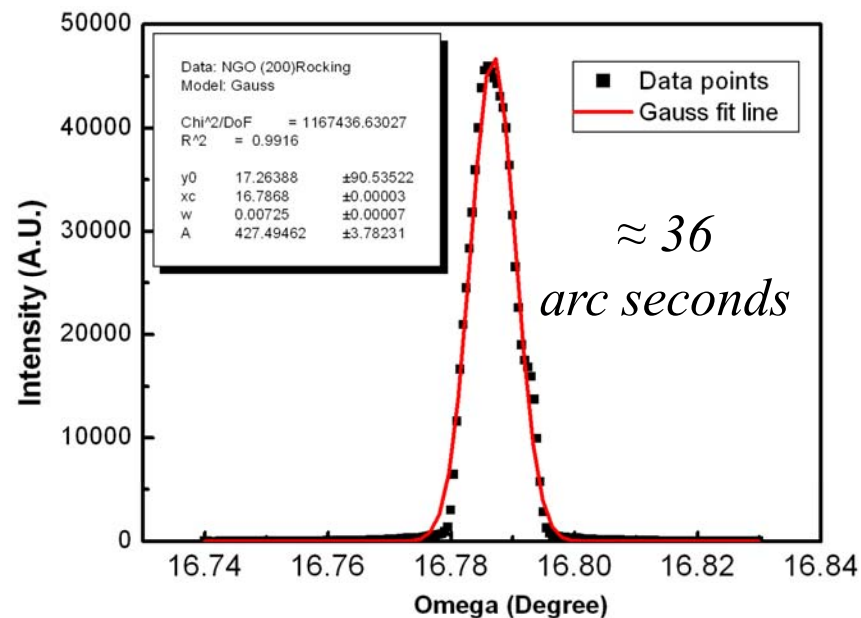
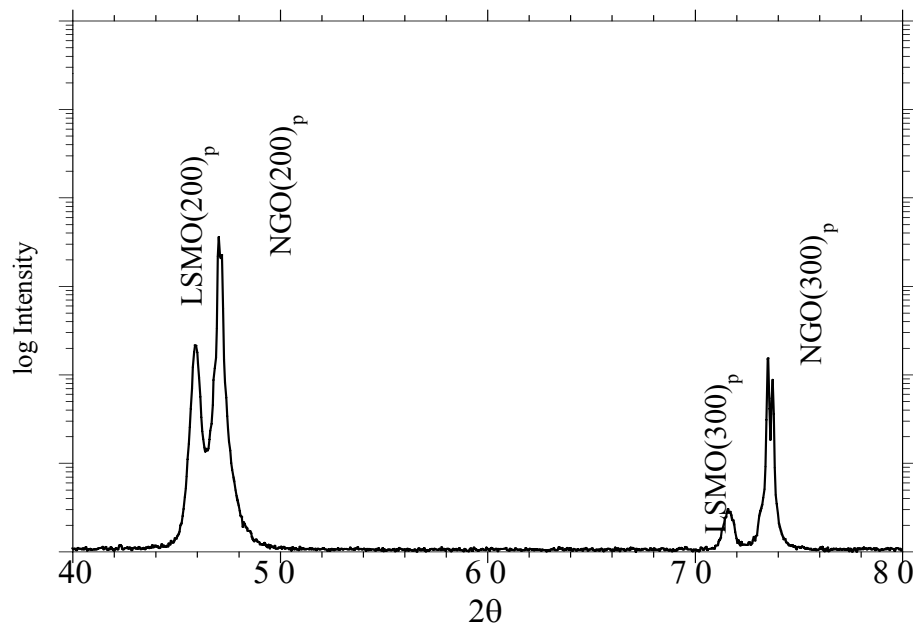
# Dislocation Control (La,Sr)MnO<sub>3</sub> thin films on NdGaO<sub>3</sub>

*Very-high Quality Perovskite Crystals*

*No Overlapping Elements with Films*

*Highly Insulating (Good for ECR / PCM)*

*La<sub>0.7</sub>Sr<sub>0.3</sub>MnO<sub>3</sub> (54 nm) deposited on NdGaO<sub>3</sub>(100)<sub>p</sub>*

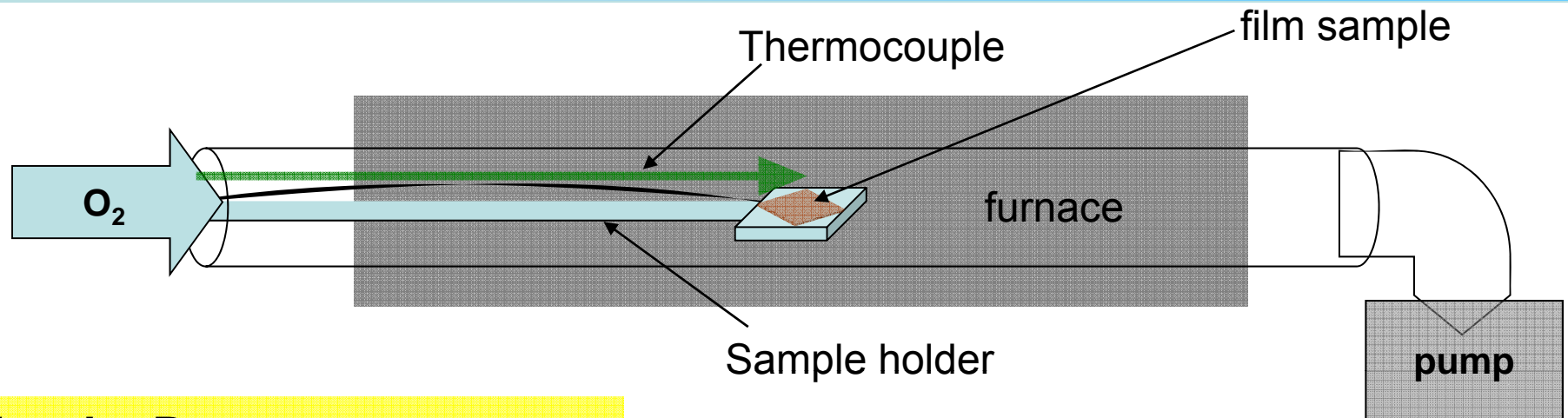


*Need Reasonable Perovskite Electrolyte(s) for Electrochemistry*

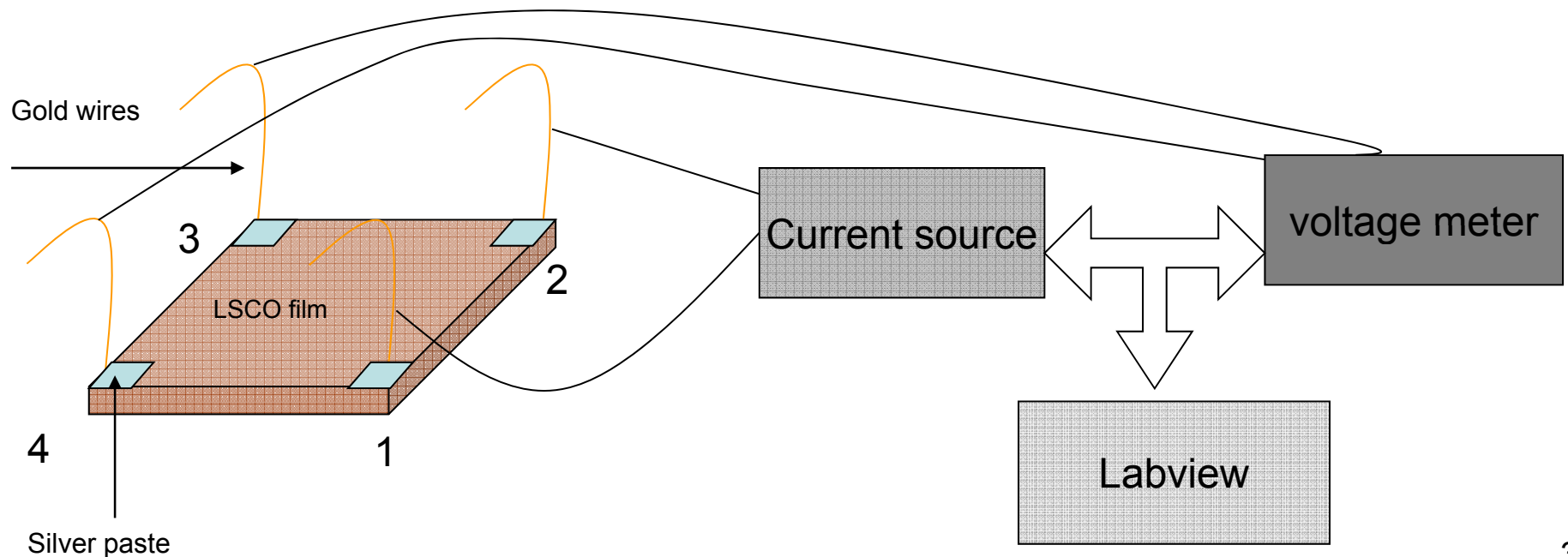
# **CMU Work for Cathode Surface Science Project**

- ***Growth of High-Quality Thin Film Samples***
  - ***Perovskite / Perovskite Epitaxy and Surface Control***
  - ***Perovskite / Fluorite Epitaxy and Surface Control***
  - *Generation of Surface-Modified Samples*
- ***Surface Kinetics for Oxygen Uptake***
  - ***Electrical Conductivity Relaxation***
  - ***Piezoelectric Crystal Microbalance Gravimetry***
  - ***Kelvin Probe Spectroscopy***
- *Surface Thermodynamics of Oxygen Uptake*
  - *Piezoelectric Crystal Microbalance Gravimetry*
  - *Kelvin Probe Spectroscopy*
- *Electronic Structure*
  - *Kelvin Probe Spectroscopy*
  - *STM (MIT)*
- *Ex-situ Surface Characterization for Correlations*
  - *Scanning Auger / XPS*

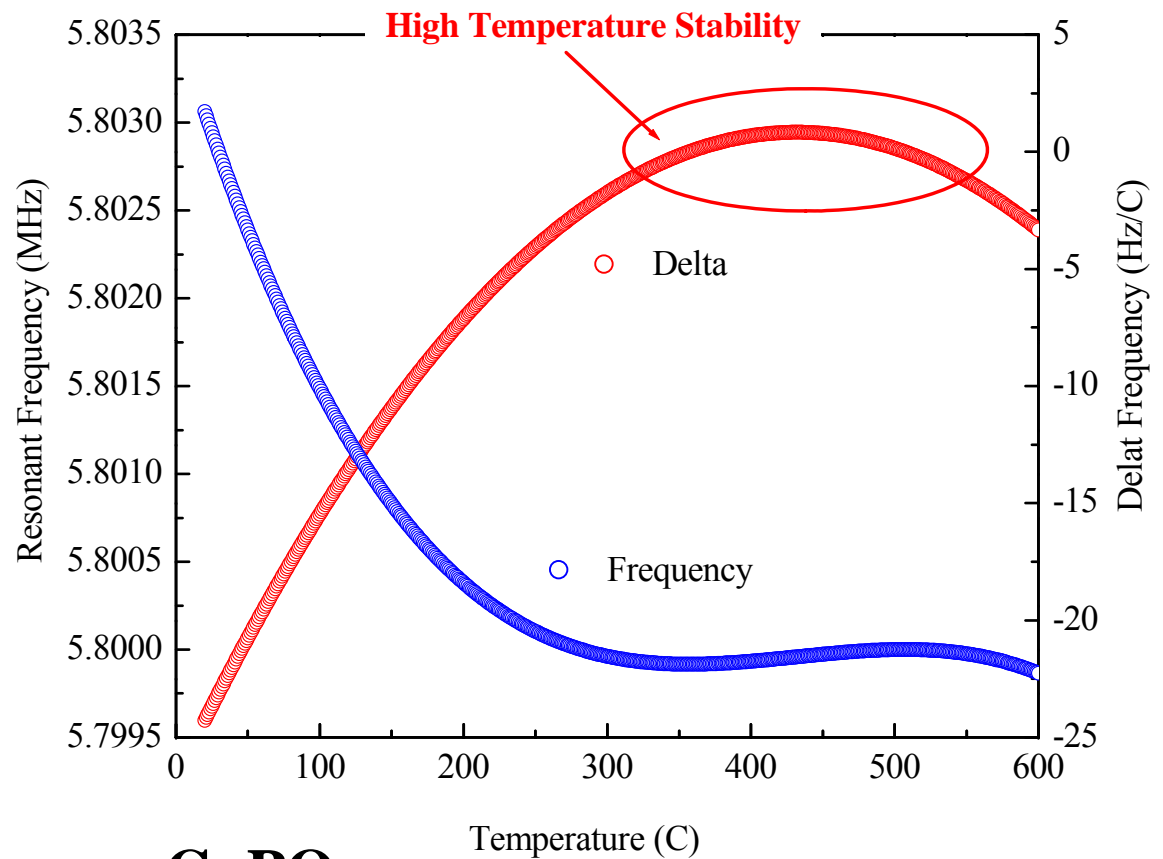
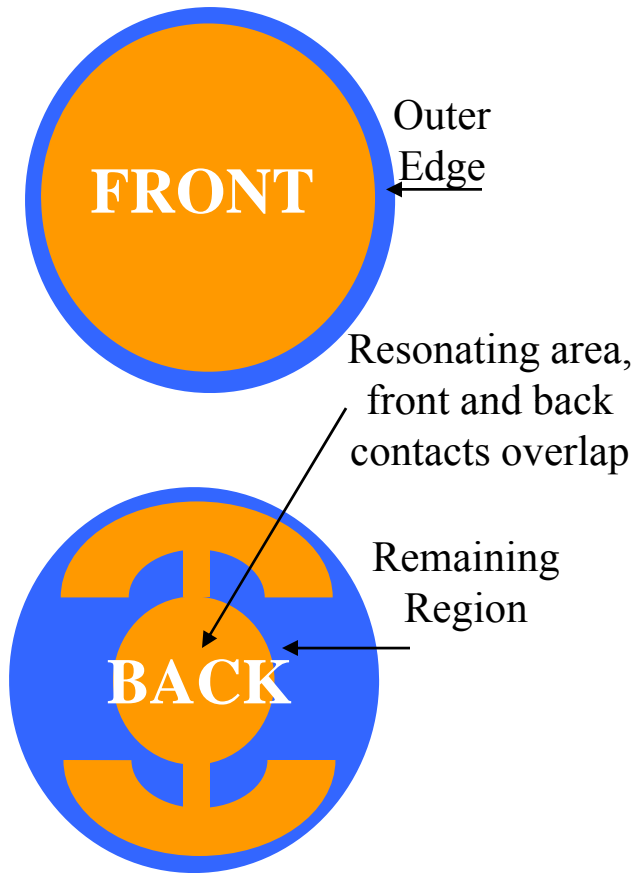
# Experimental Approach for ECR: Determine surface exchange constant $k_{chem}$



## Van der Pauw measurement:



# Gravimetry



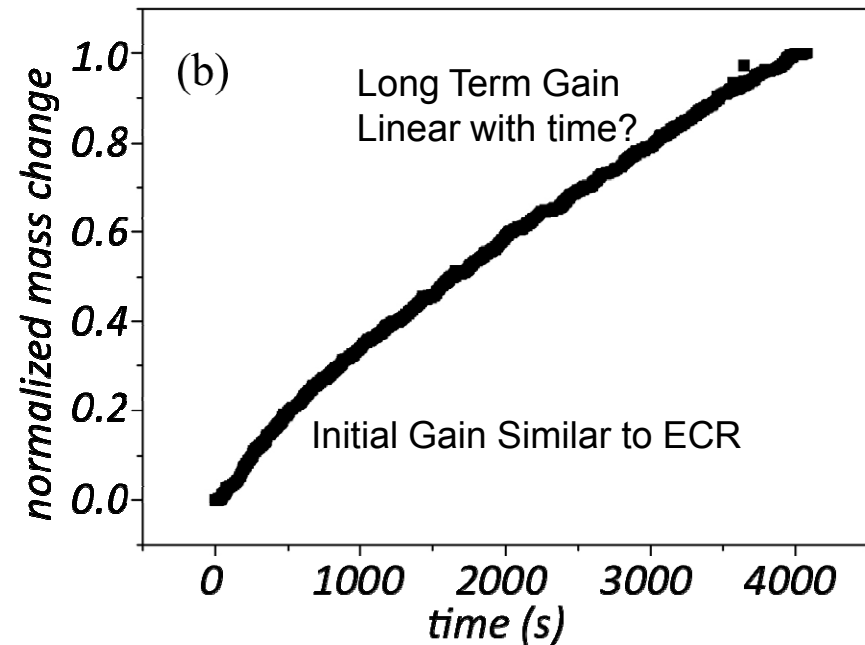
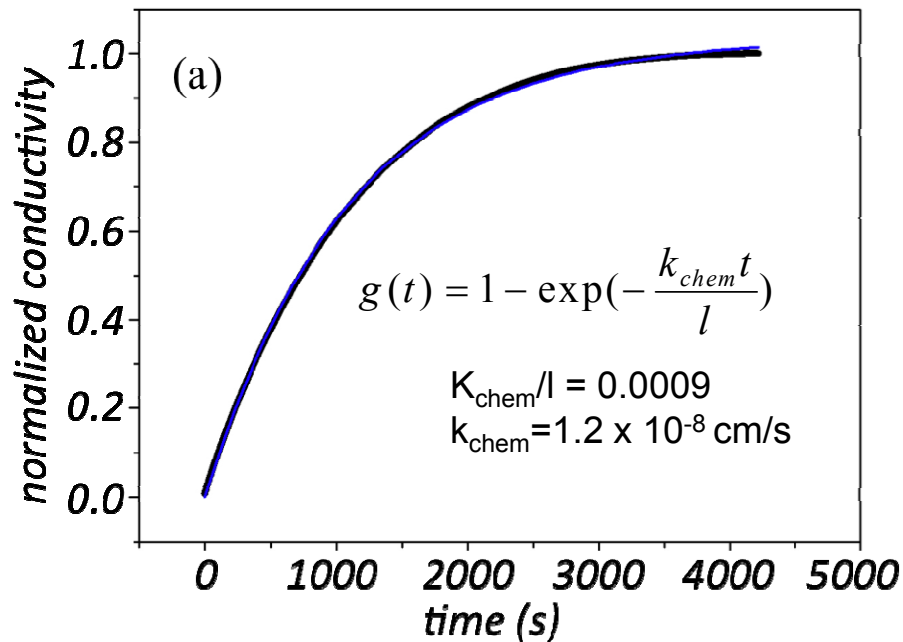
**GaPO<sub>4</sub>**

**Diameter = 0.55 inch; Thickness = 0.2 mm;**

**F<sub>0</sub> = 5.8 MHz, Sensitivity +/- 3 Hz**

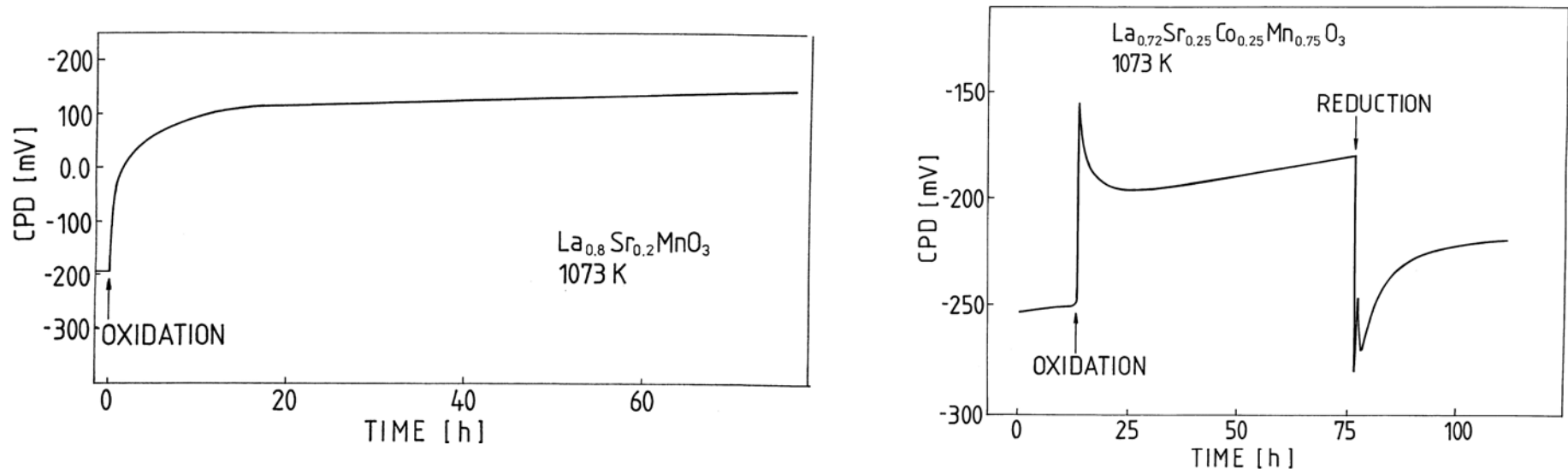
## Combined ECR and PCM

- $\text{LaNiO}_3$  is a well known conducting perovskite
- $\text{LaNiO}_3$  is suitable material for measurement of oxygen uptake range of 300-500°C
- $\text{LaNiO}_3$  grows on YSZ (100) and on STO (100) similar to LSM
- 3 mTorr  $\text{O}_2$  to 10 mTorr  $\text{O}_2$  in a total pressure of 220mTorr (nitrogen balance)



# Kelvin Probe Spectroscopy

Badwal et al. *J. Phys. Chem. Sol.* **62**, 723 (2001)



Several Different Regimes Observed on PolyXtal Ceramics

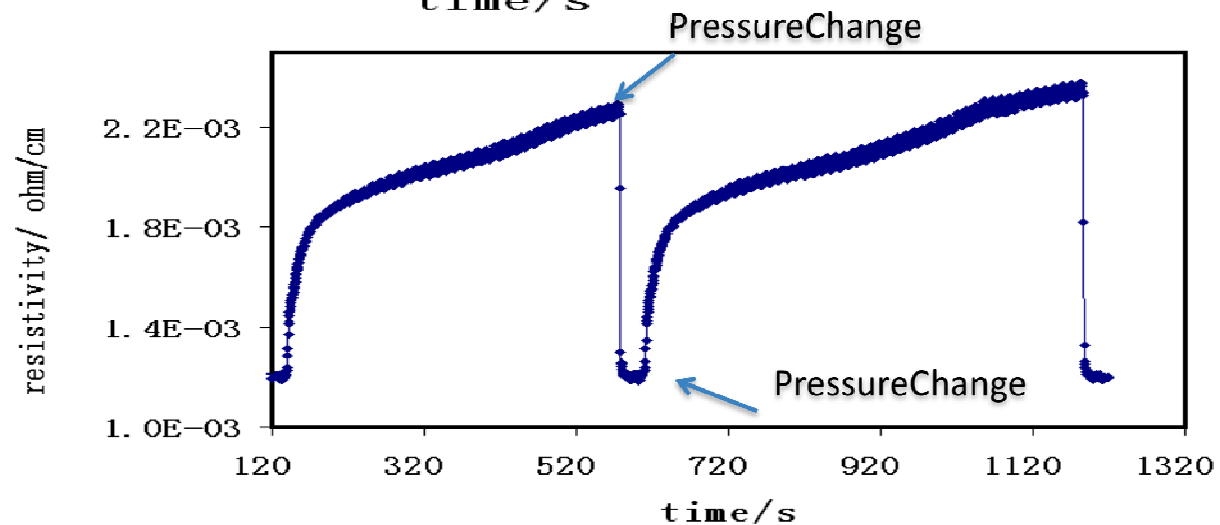
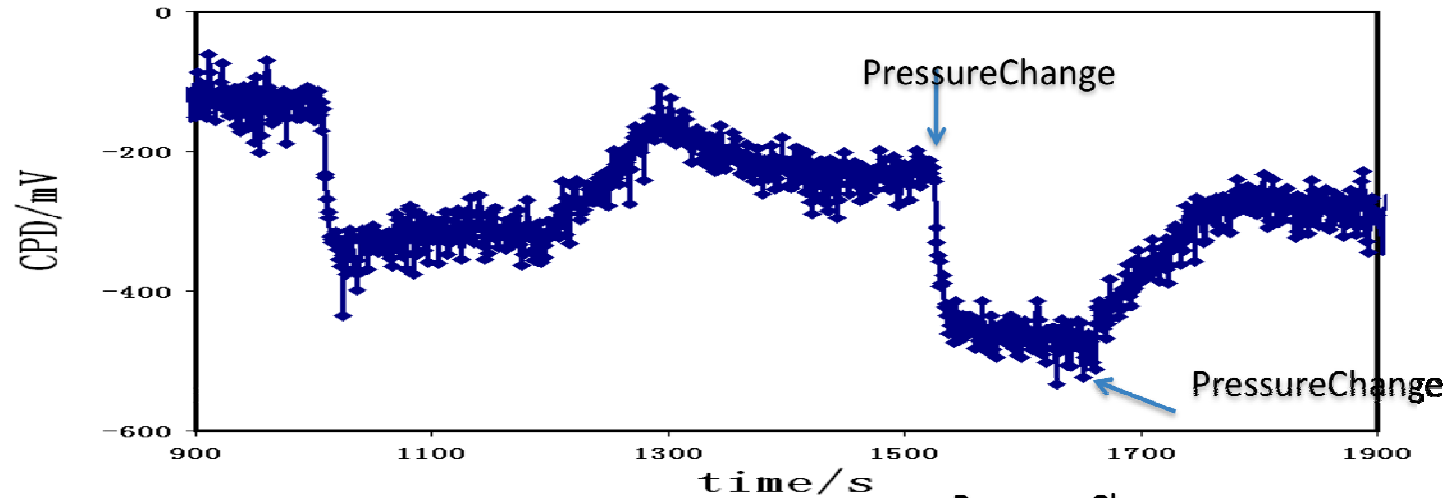
Should Correlate with conductivity AND sensitive mass measurements  
deconvolute surface / bulk effects

Requires Consistent surface engineered samples

# Combined ECR and KPS

LSCO 100nm-YSZ(111)

800C;  $\text{PO}_2$ :  $\text{N}_2$  to  $\text{O}_2$  1atm



## *Outline*

- Microstructural Characterization
  - Activity / Stability Issues
  - Oxygen Reduction Reaction
- Cathode Surface Fabrication / Characterization
  - Thin Film Geometry Synthesis
  - Combined Thin Film Property Measurements
- **Electrical Conductivity Relaxation on LSM**
  - **Film Structures and Properties vs Bul**
  - **Orientation Dependence of oxygen uptake**
  - **Temperature Dependence of oxygen uptake**
  - **Substrate Dependence of oxygen uptake**



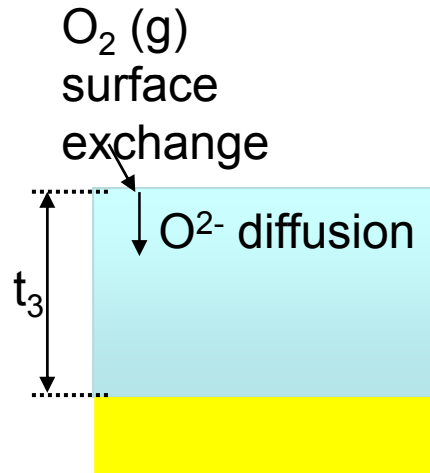
# Thin film geometry selection

Characteristic length of the sample:

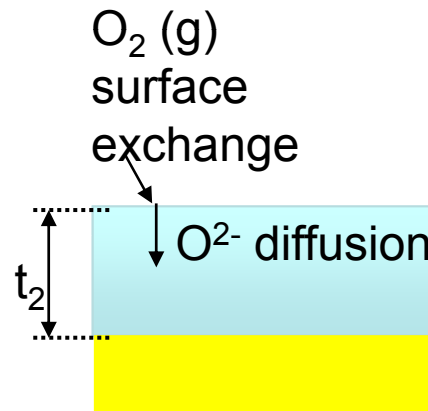
$$l_d = \bar{D}/k$$

$\bar{D}$  :chemical diffusion coefficient

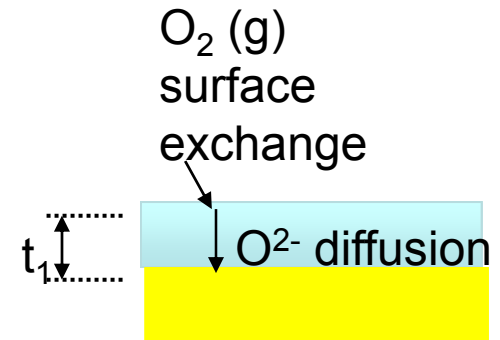
$k$  :surface exchange coefficient



$$t_3 \gg l_d$$
$$\bar{D}$$



$$t_2 \approx l_d$$
$$\bar{D}, k$$



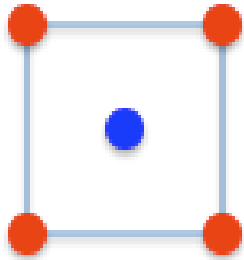
$$t_1 \ll l_d$$
$$k$$

To isolate the surface influence on oxygen exchange process, film thickness should be smaller than critical value.

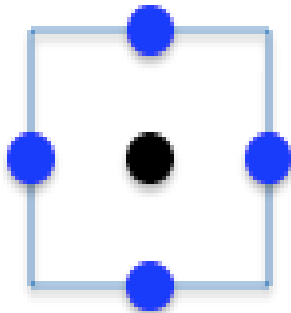
# *Ideal Surface Terminations*

(100)

**AO**

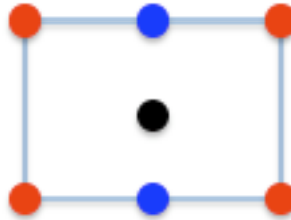


**BO<sub>2</sub>**

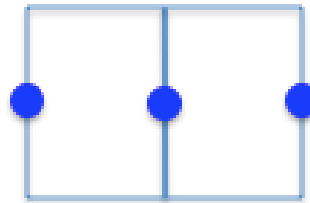


(110)

**ABO**

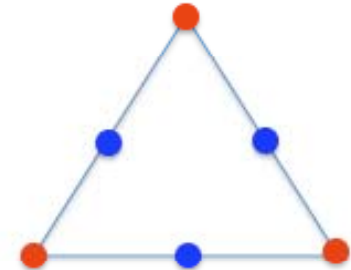


**O<sub>2</sub>**

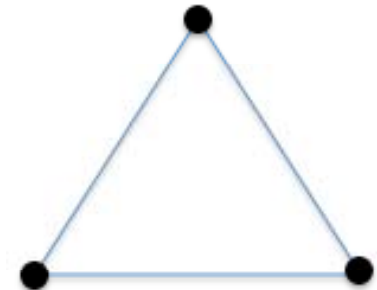


(111)

**AO<sub>3</sub>**



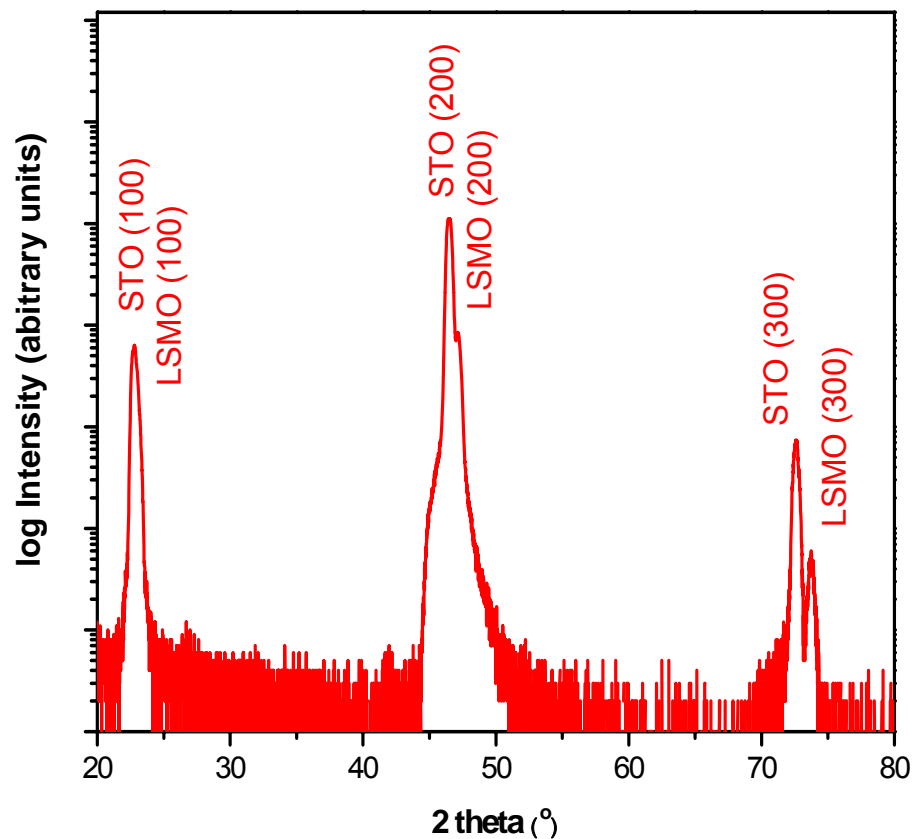
**B**



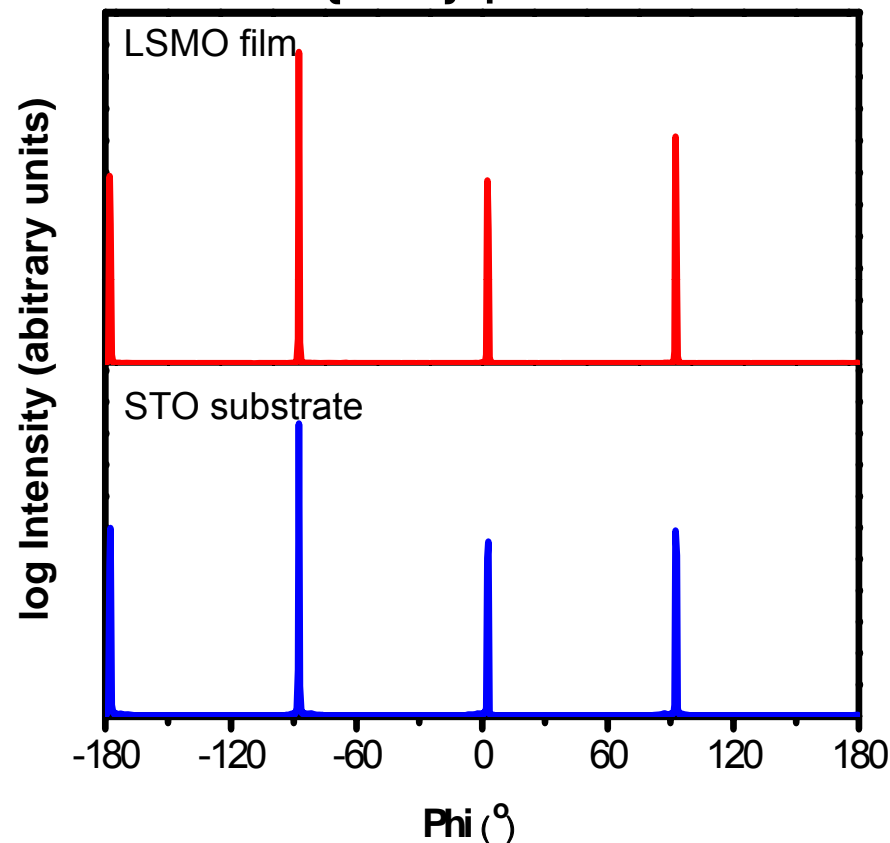
Different Types and Numbers of Broken Bonds on Surfaces

# LSMO thin film growth on STO (100) substrates

LSMO-STO(100)

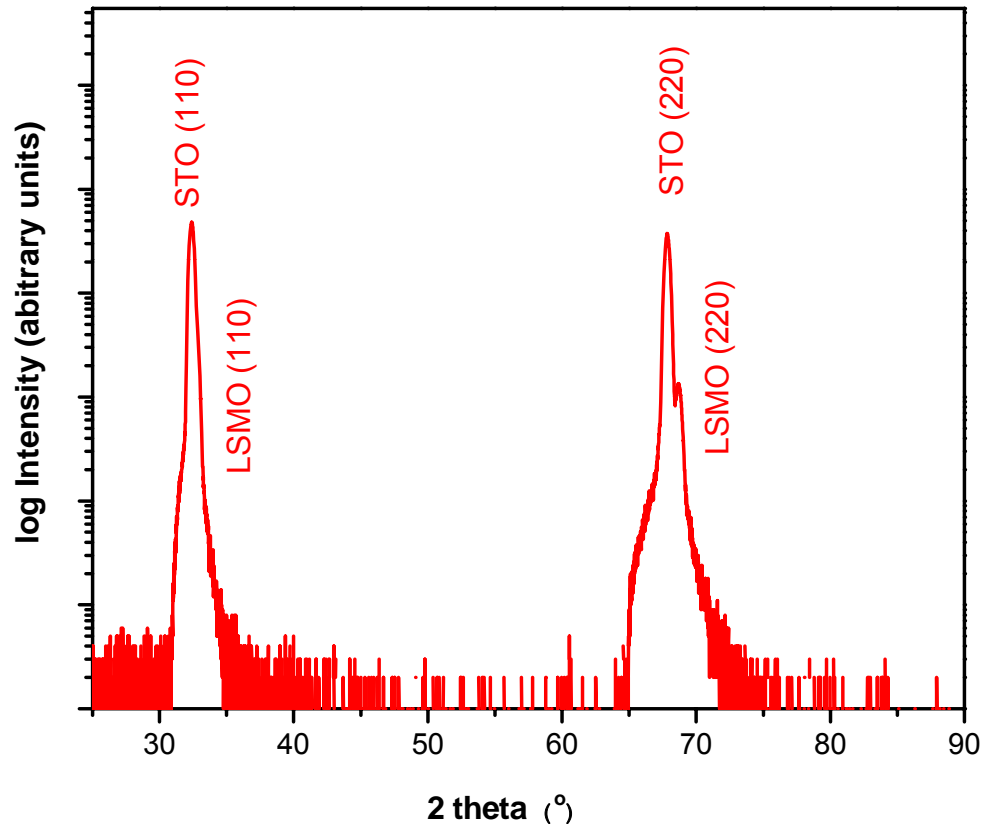


{110} phi scan

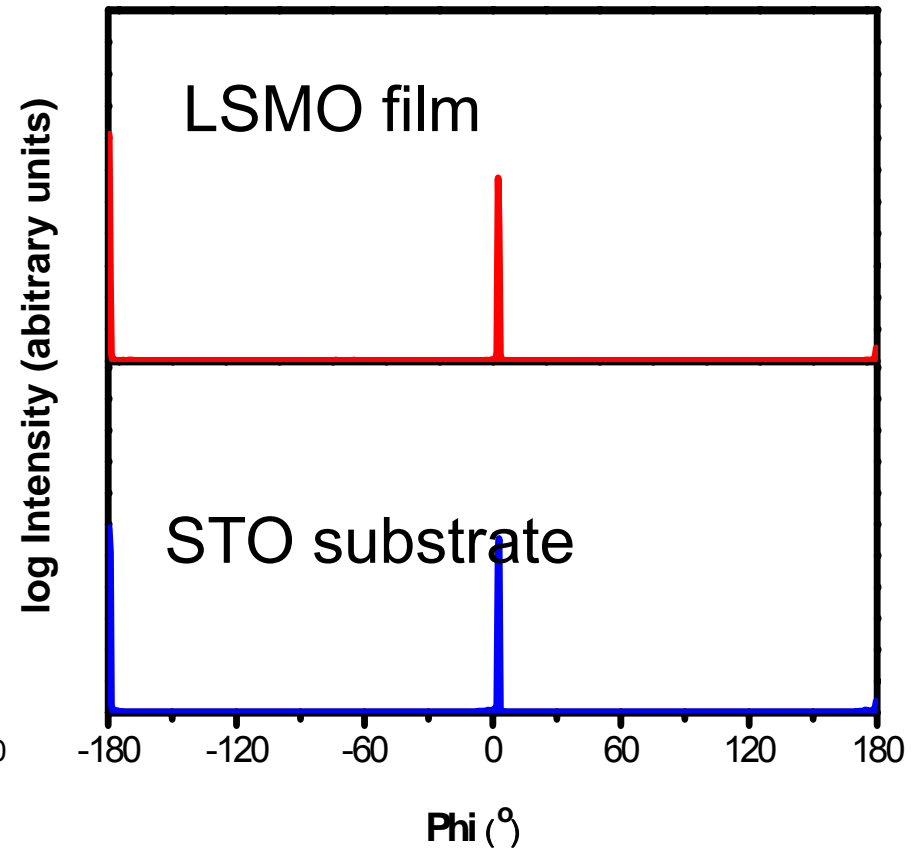


# LSMO thin film growth on STO (110) substrates

LSM-STO(110)

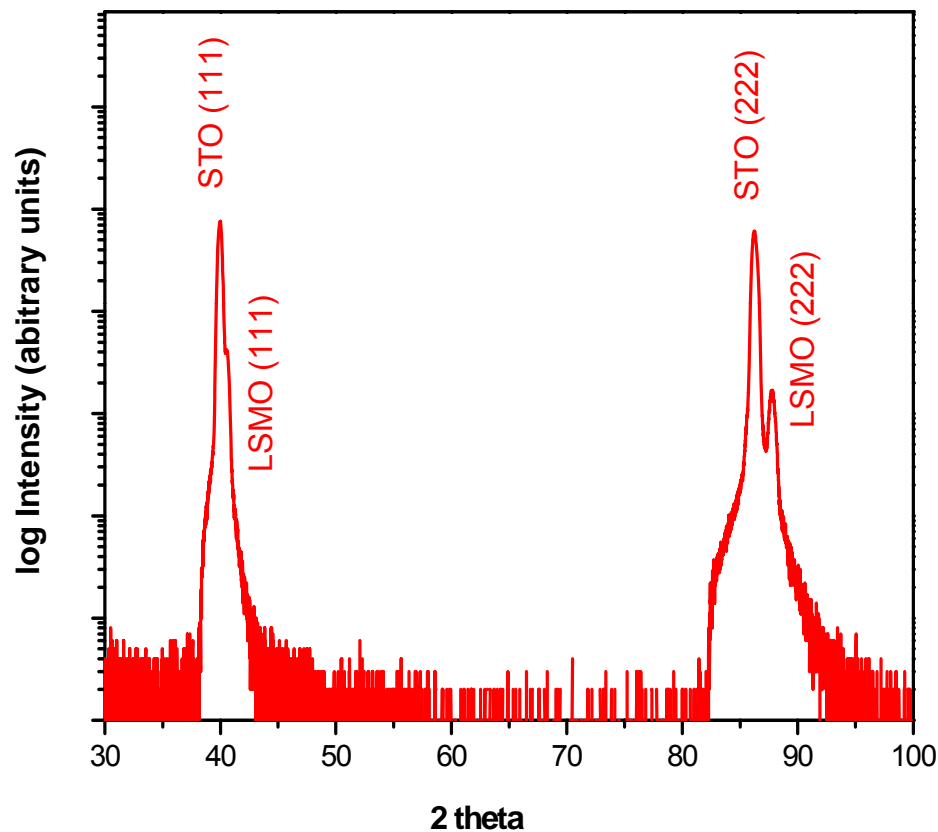


{100} phi scan

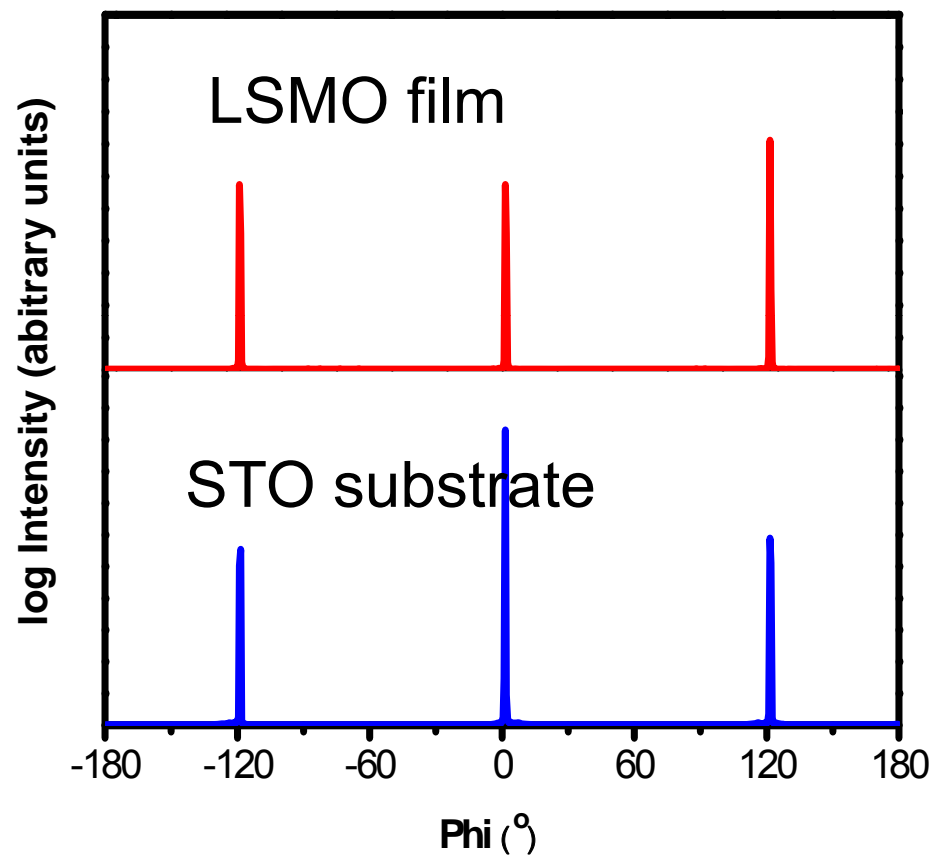


# LSMO thin film growth on STO (111) substrates

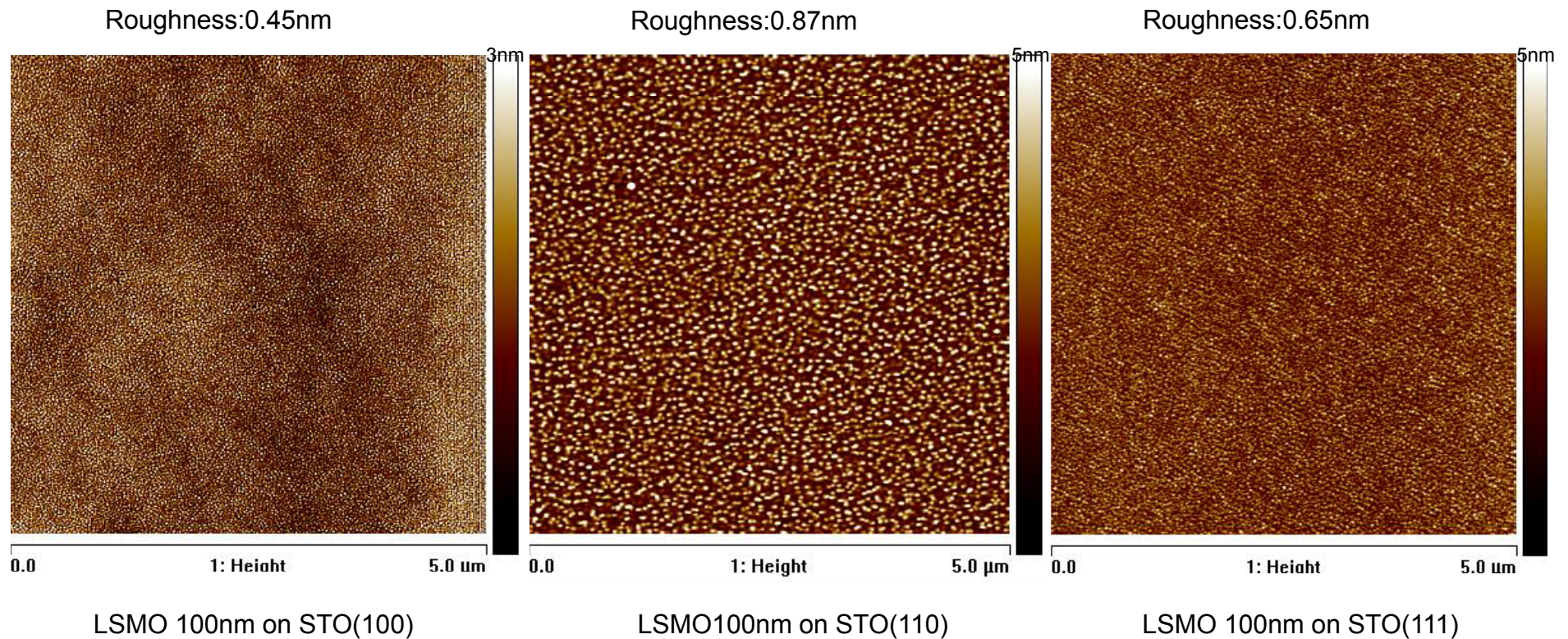
LSMO-STO(111)



{110} phi scan



# Cathode thin film surface on STO substrates



- Surface features are well defined.
- Films are unit-cell smooth.



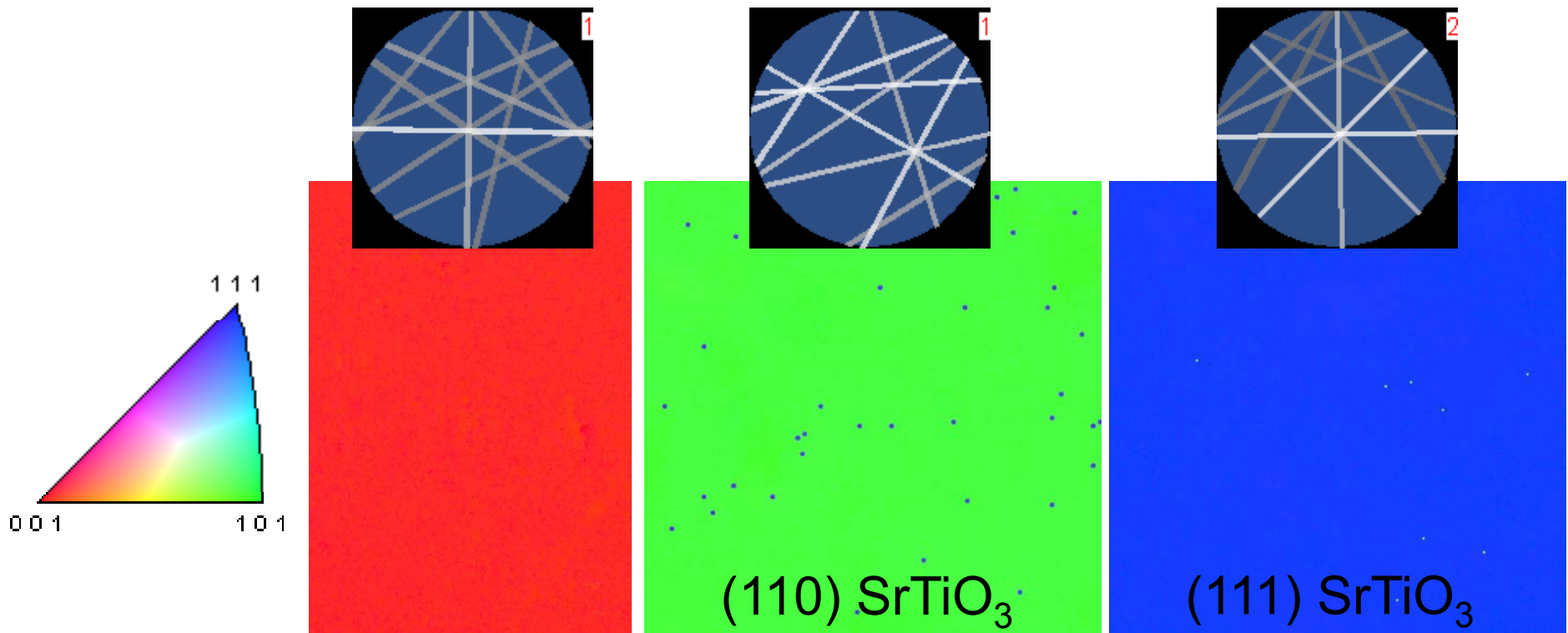
# Epitaxy along various Orientations

## Orientation Mapping / Surface Sensitivity

*Electron Back-Scattered Diffraction used to Identify Local Orientations*

*$\text{La}_{0.7}\text{Sr}_{0.3}\text{MnO}_3$  (50 nm) deposited on  $\text{SrTiO}_3$*

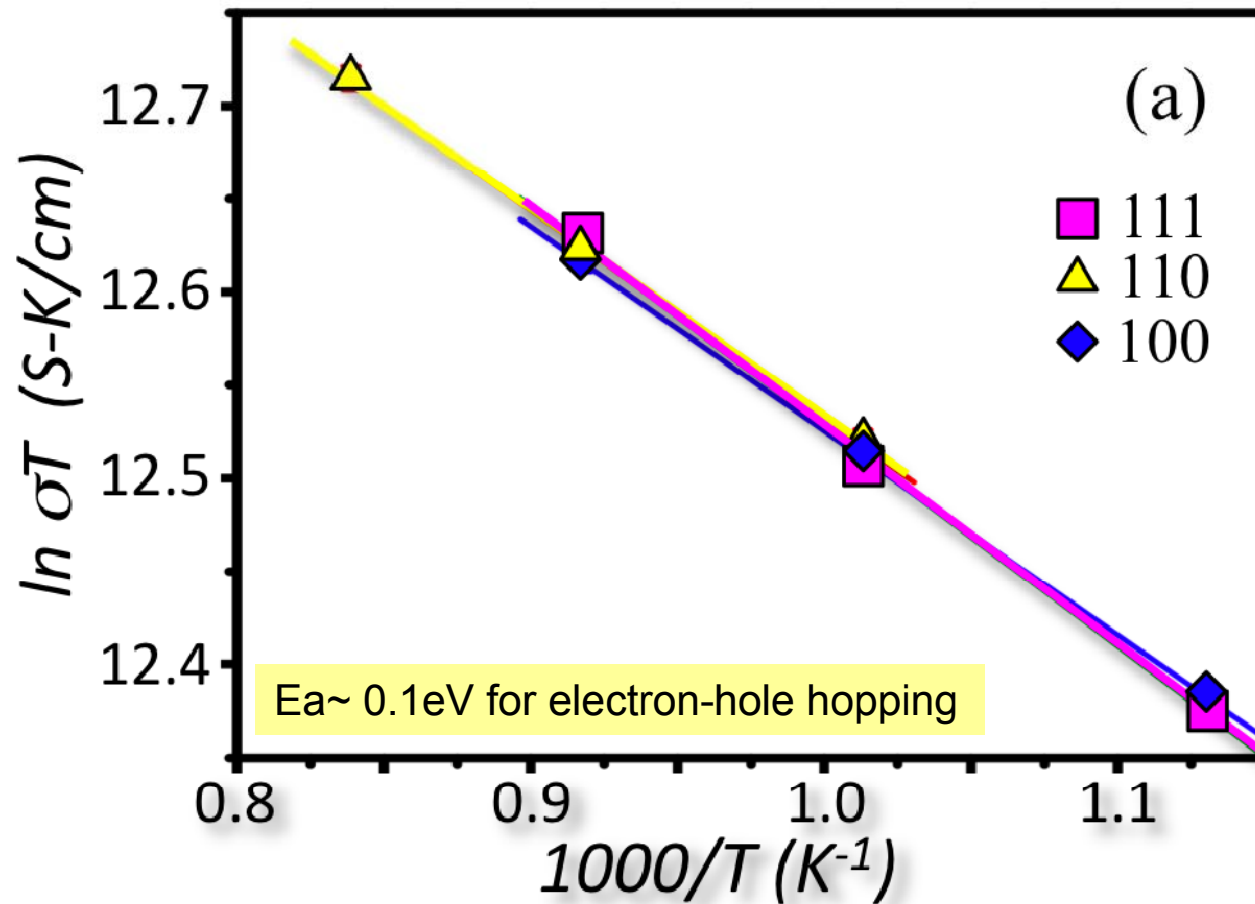
*All scan areas > 20 x 20 micron<sup>2</sup>*



*All three low-index surfaces are obtained as epitaxial films*

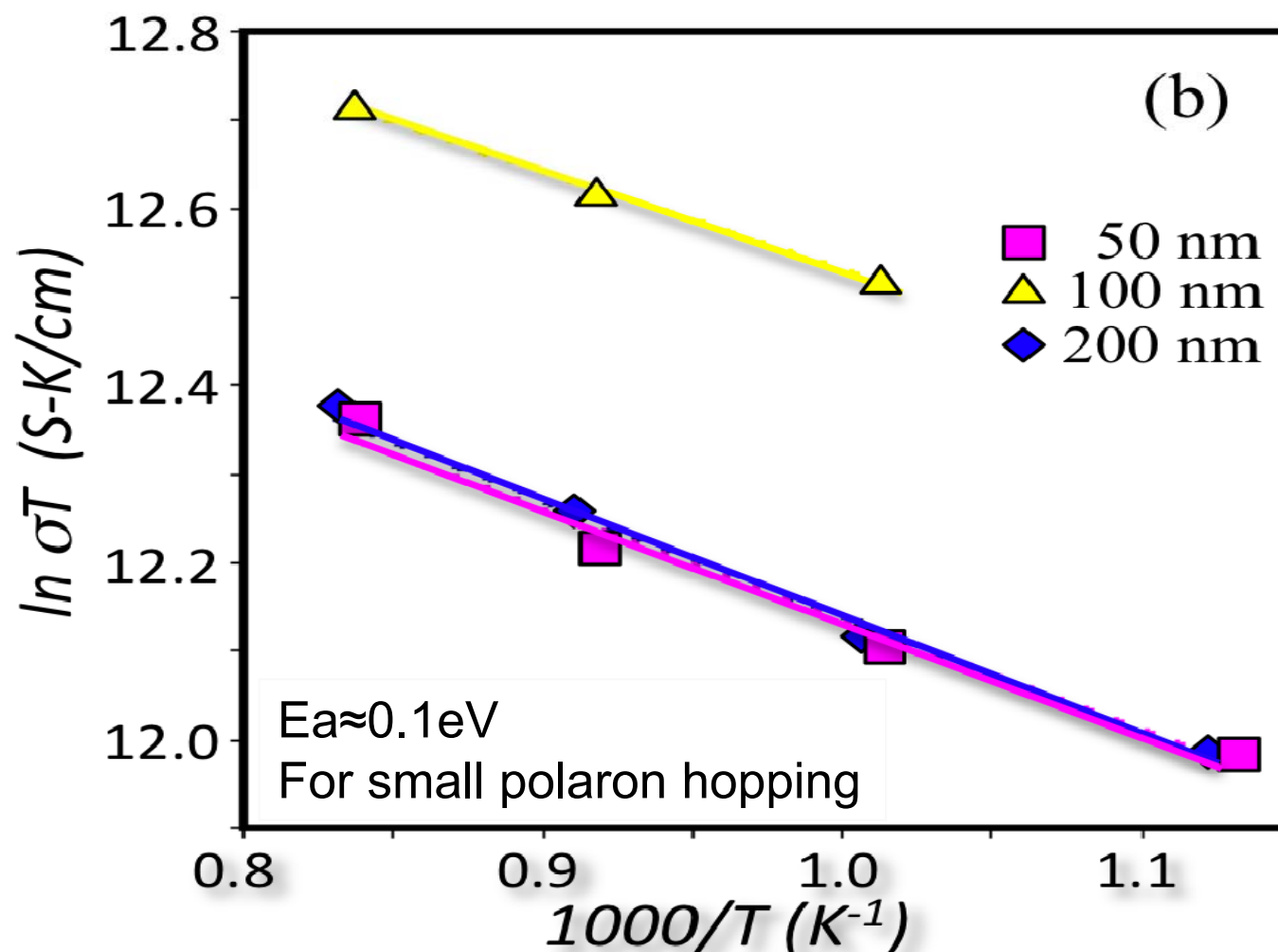


LSMO film conductivity dependency on temperature  
 $\text{PO}_2=500\text{mTorr}$



100nm thick LSMO films show resistivity  $\approx 0.9 \text{ m}\Omega/\text{cm}$ , activation energy  $\approx 0.1 \text{ eV}$ . Experimental data show good agreement with reported value for LSMO films.

## *(110) LSMO (70/30) conductivity change with temperature*



50-200 nm thick LSMO films show resistivity  $\approx 0.9 \text{ m}\Omega/\text{cm}$ , activation energy  $\approx 0.1 \text{ eV}$ . Experimental data show good agreement with reported value for LSMO films.

# Perovskite defect concentration vs $P_{O_2}$

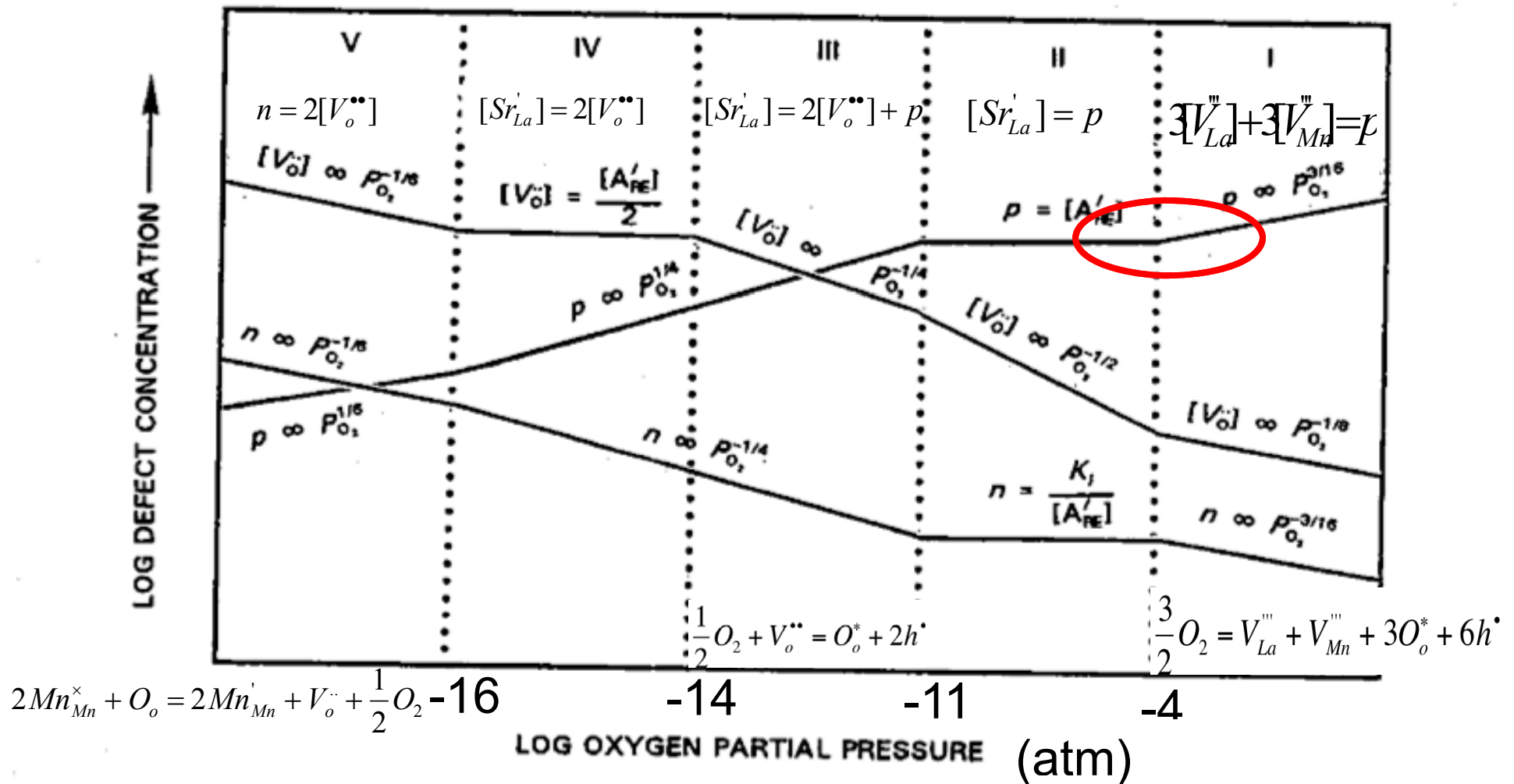
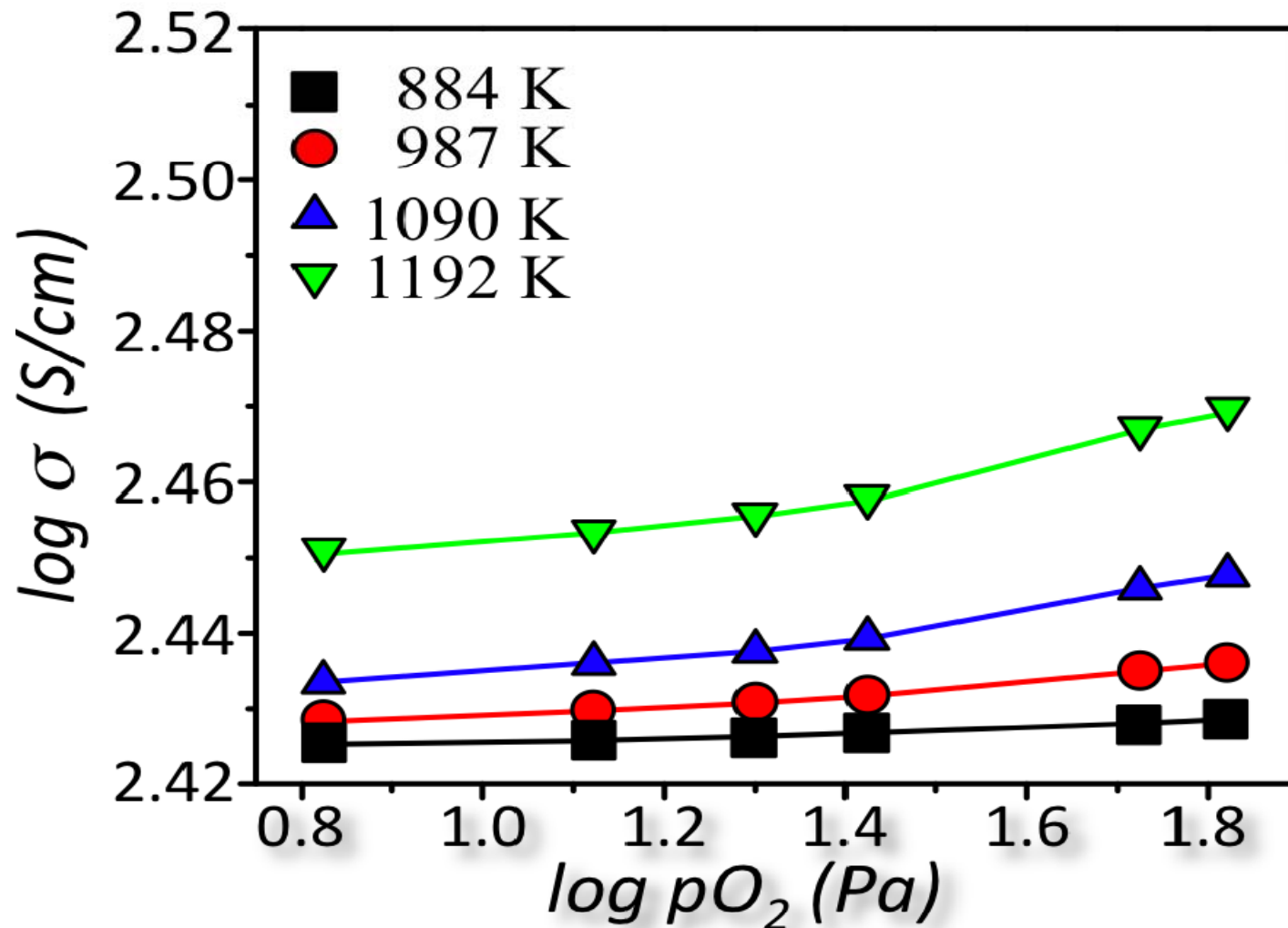


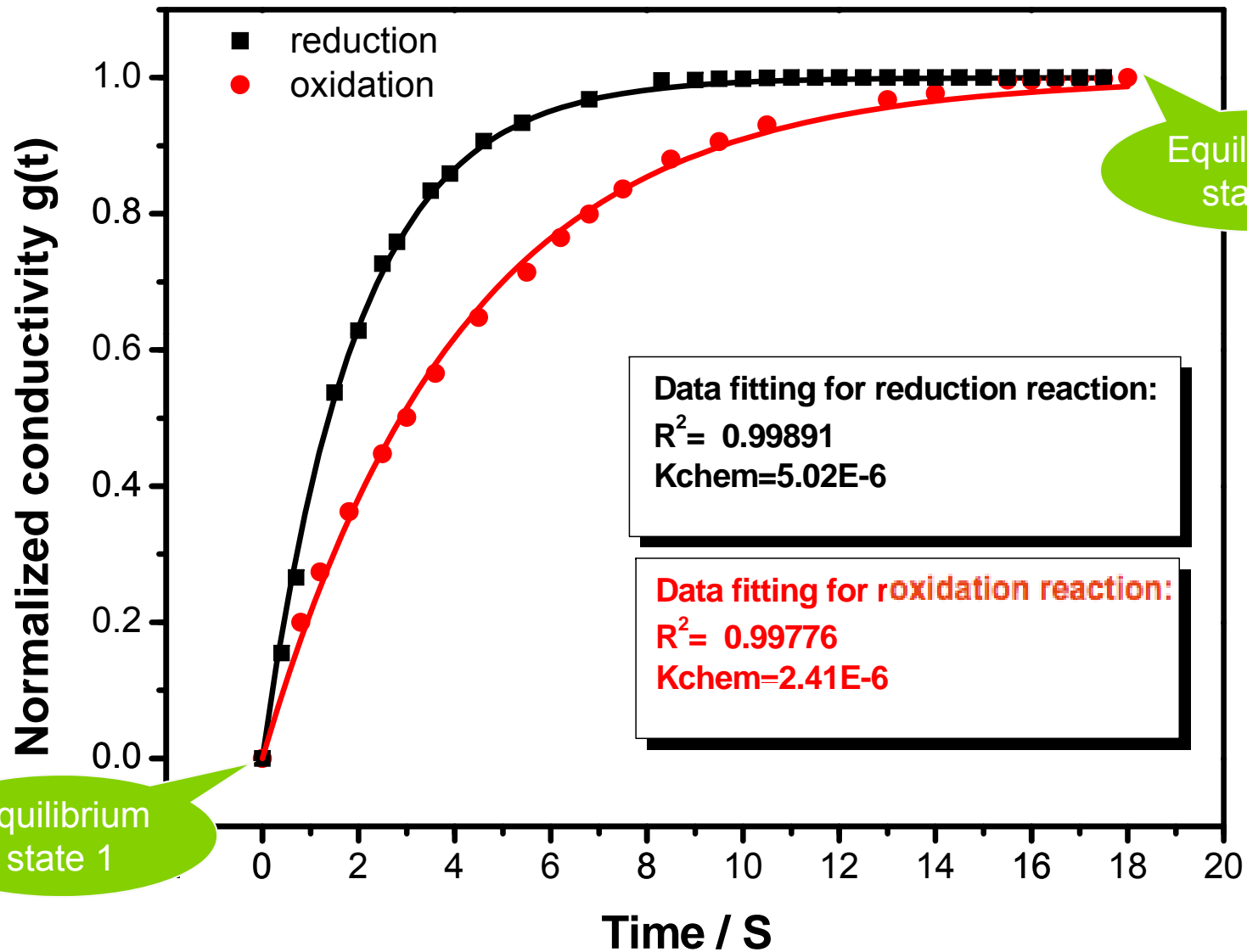
Figure 3.7. Defect concentration as a function of oxygen partial pressure for a rare-earth perovskite oxide

## LSMO (111) film conductivity dependency on $\text{PO}_2$



Transition region, slope gradually increases which coincide with theory and the slopes lie between 3/16 to 0 according to theoretical calculation.

# ECR data fitting for fast and slow surface exchange processes



# Diffusion models for surface exchange controlled reaction

$J_{in}$ : flux into the sample

$K_{chem}$ : surface exchange coefficient

Linear flux-force relationship:

$$J_{in} = -K_{chem}(c_t - c_{final}) \quad \text{Eq.(1)}$$

$c_{final}$ : concentration at the final equilibrium state.

$c_t$ : nonstoichiometric species' concentration at time  $t$

According to Fick's 2<sup>nd</sup> law with  $J_{out}=0$ :

$$\frac{\partial c}{\partial t} = \frac{\partial J}{\partial x} = -\frac{K_{chem}}{L}(c_t - c_{final}) \quad \text{Eq.(2)}$$

$L$ : sample thickness

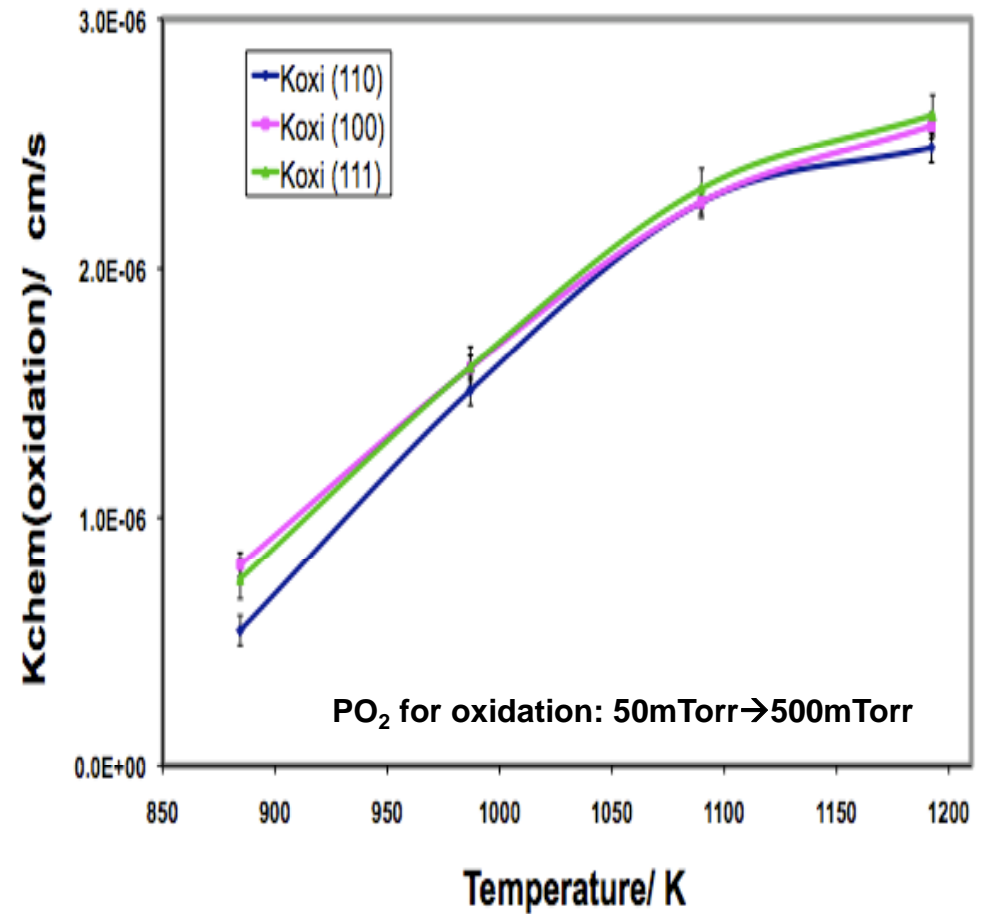
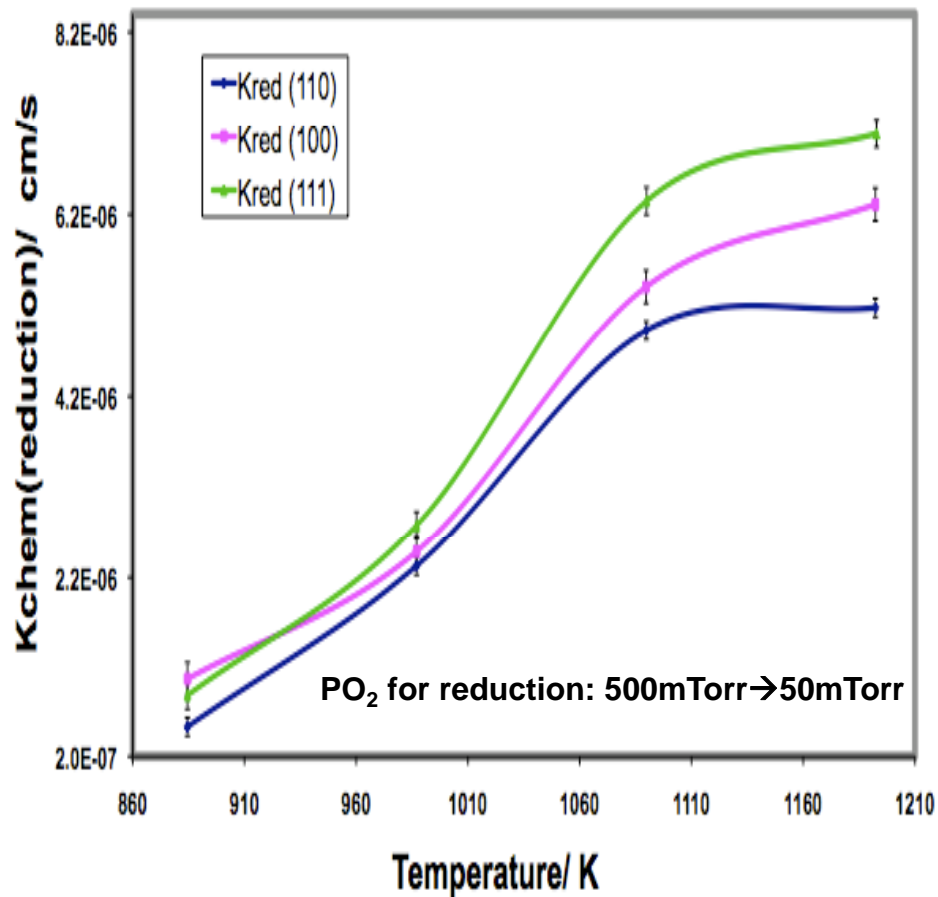
Integration gives:

$$\frac{c_t - c_{initial}}{c_{final} - c_{initial}} = 1 - \exp\left(-\frac{K_{chem}t}{L}\right) = 1 - \exp\left(-\frac{t}{\tau}\right) \quad \text{Eq.(3)}$$

$c_{final}$ : concentration at the final equilibrium state.

$\tau$ : time constant

## $K_{\text{chem}}$ dependency on film orientation





# $K_{\text{chem}}$ dependency on film orientation data sheet

	T1(K)		T2(K)		T3(K)		T4(K)	
$K_{\text{chem}}$ (reduction)	1192 K	$\frac{K_i - K_{\text{max}}}{K_{\text{max}}}$	1090 K	$\frac{K_i - K_{\text{max}}}{K_{\text{max}}}$	987 K	$\frac{K_i - K_{\text{max}}}{K_{\text{max}}}$	885 K	$\frac{K_i - K_{\text{max}}}{K_{\text{max}}}$
111	7.09E-06	0%	6.35E-06	0%	2.78E-06	0%	0.91E-06	17%
100	6.31E-06	11%	5.41E-06	15%	2.49E-06	11%	1.09E-06	0%
110	5.18E-06	27%	4.93E-06	22%	2.33E-06	16%	0.56E-06	48%
$K_{\text{chem}}$ (oxidation)								
111	2.62E-06	0%	2.32E-06	0%	1.61E-06	0%	0.75E-06	7%
100	2.57E-06	2%	2.27E-06	2%	1.60E-06	0%	0.81E-06	0%
110	2.49E-06	5%	2.26E-06	2%	1.51E-06	6%	0.54E-06	33%

# Revisiting Anisotropy

Surface anisotropy of cathode materials  $\longrightarrow$  oxygen surface exchange process.  
 Different orientations  $\longrightarrow$  Different  $K_{chem}$

- *Total broken bond density. If true, then*

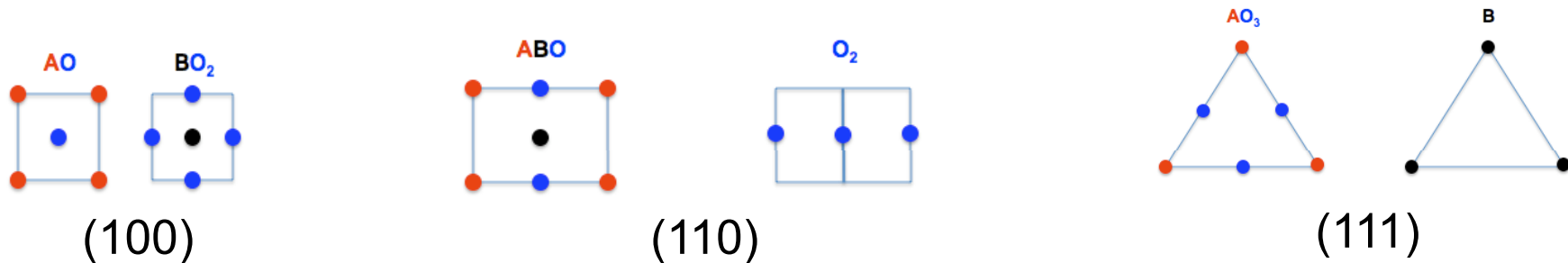
$$K_{chem}(100) \approx K_{chem}(110) > K_{chem}(111).$$

- *Broken MnO bond density. If true, then*

$$K_{chem}(111) > K_{chem}(110) > K_{chem}(100).$$

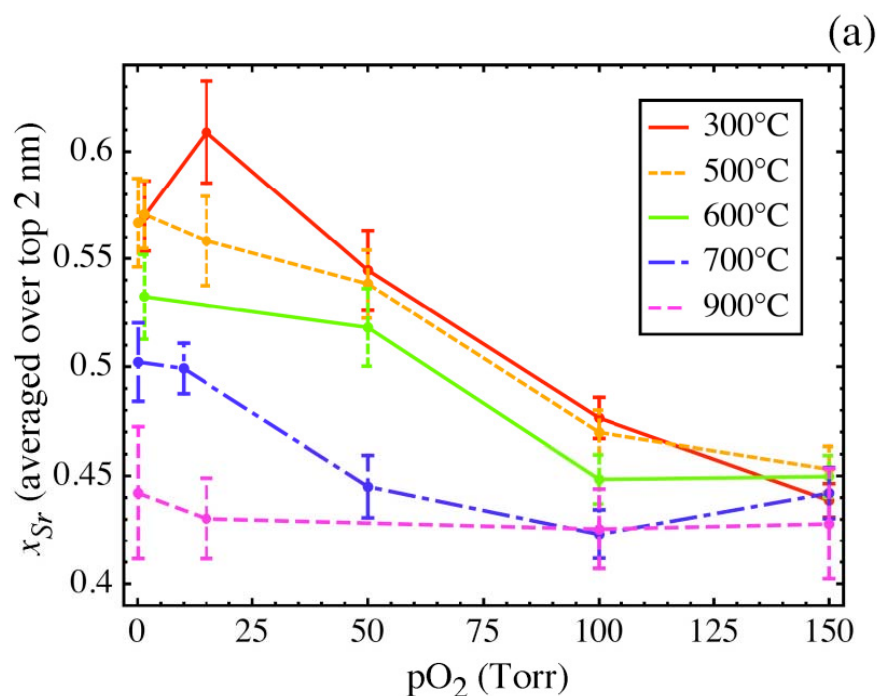
- *50-50 coverage of 2 terminations, and broken MnO bond*

$$K_{chem}(111) > K_{chem}(100) > K_{chem}(110).$$

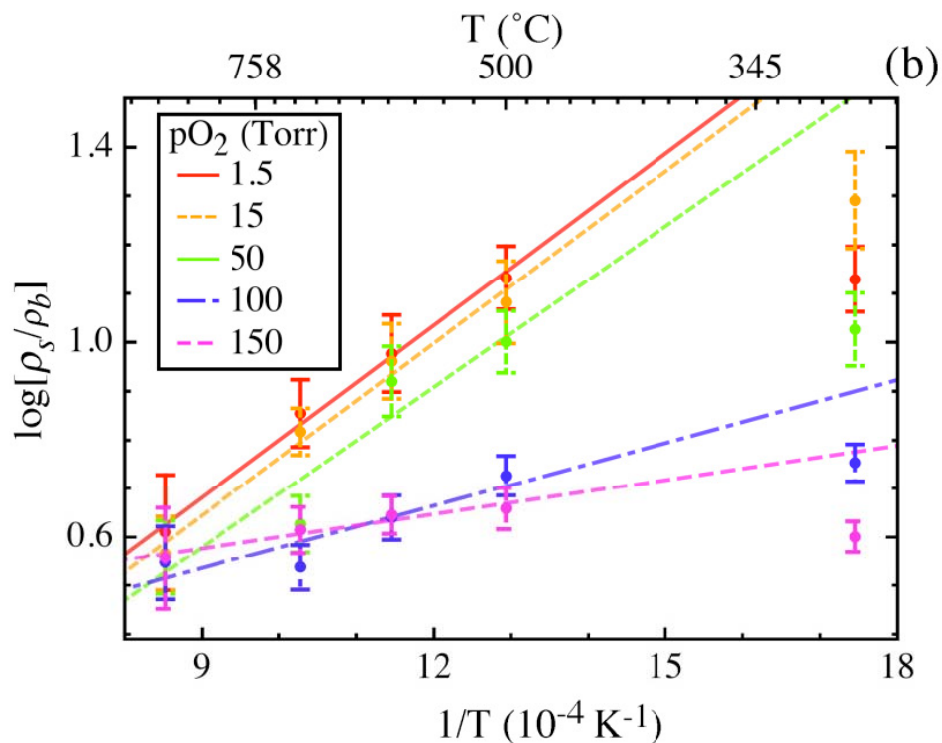


# Strontium Segregation vs $T$ and $P$

16 nm LSMO on DyScO<sub>3</sub>,  
700°C, pO<sub>2</sub> = 150 Torr

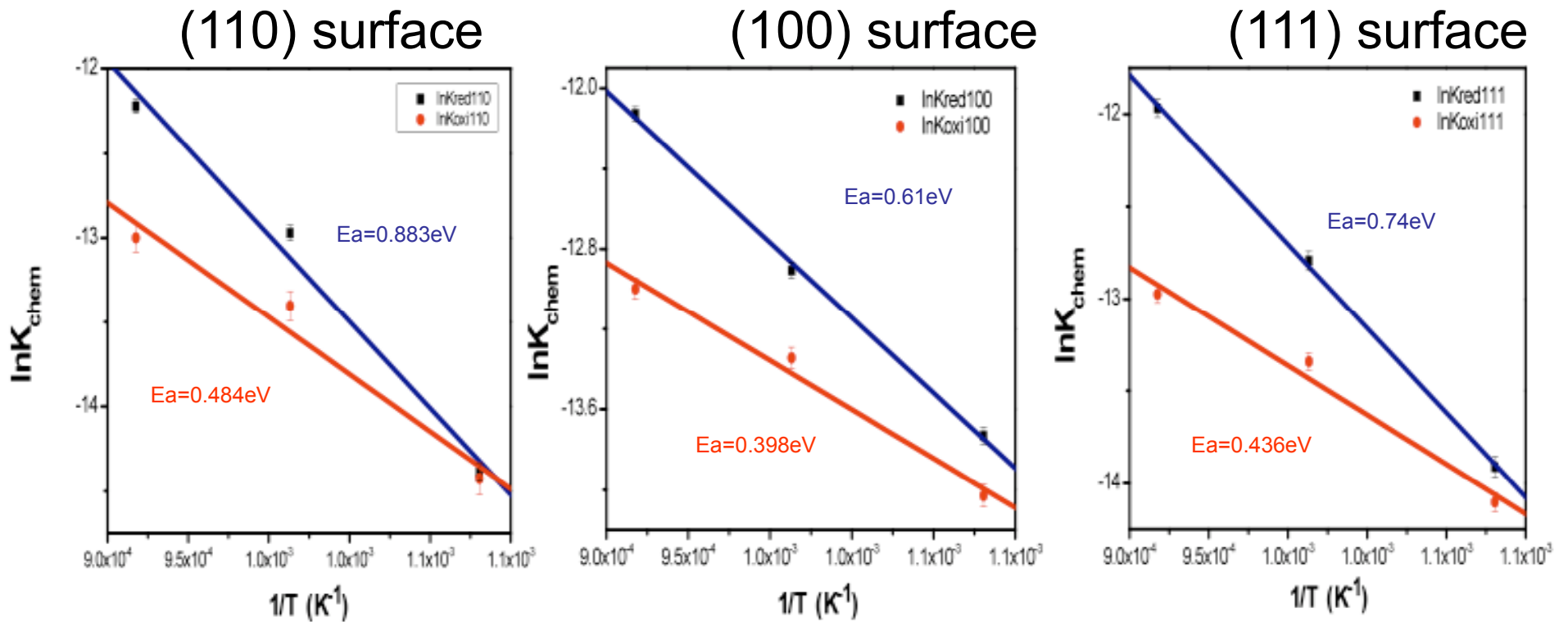


16 nm LSMO on DyScO<sub>3</sub>,



- Observe that Sr segregation depends on both  $T$  and  $pO_2$ 
  - plot shows average Sr composition in ~3 nm surface region (bulk composition = 0.3)

# $K_{\text{chem}}$ dependency on temperature for LSMO films

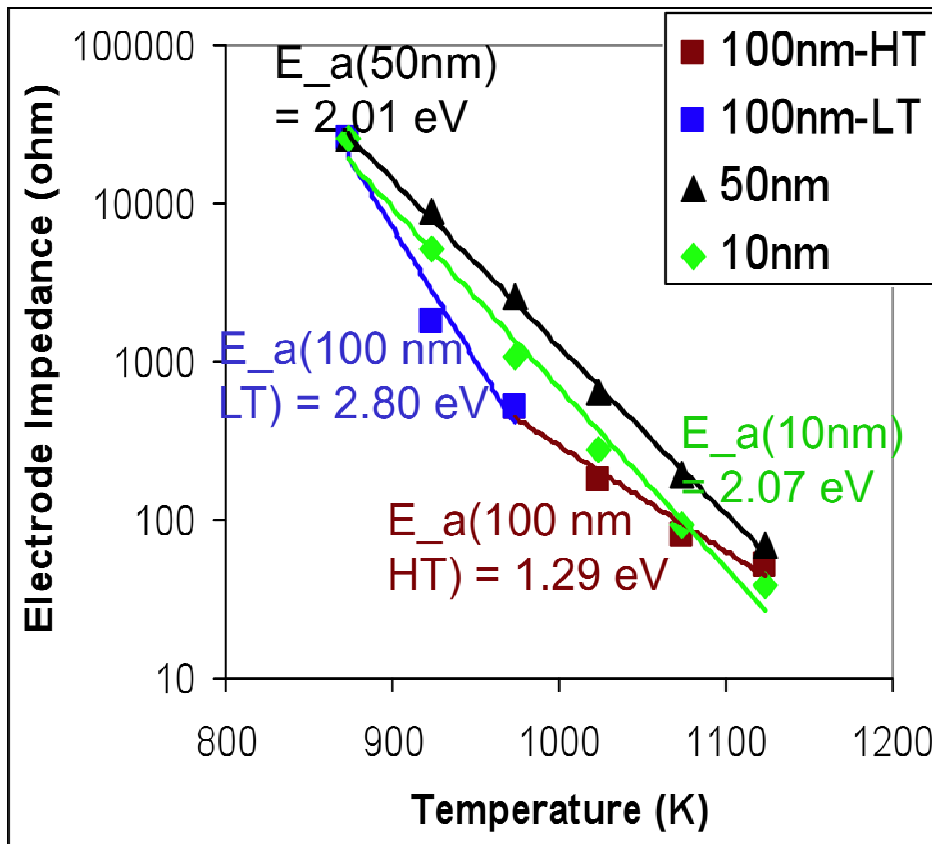


$K_{\text{chem}}^{\text{reduction}} > K_{\text{chem}}^{\text{oxidation}}$

Physical adsorption/desorption might be the rate limiting steps for oxygen exchange.

# Impedance vs Thickness and Temperature

IS at MIT of Films prepared at CMU  
B. Kavaipatti, P. Salvador, B. Yildiz



**2eV of effective activation energy indicates surface-limited oxygen reduction [1,2]**

**HT region for 100nm thick film indicates a change in the mechanism**

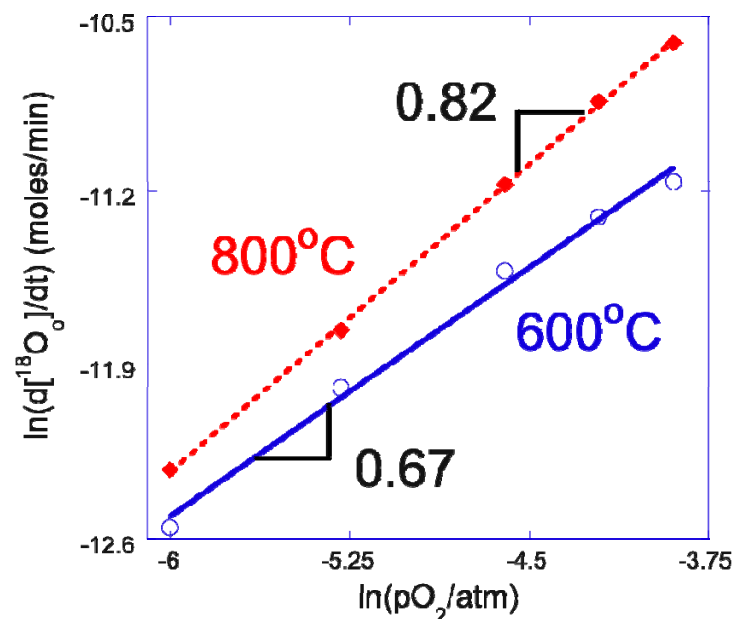
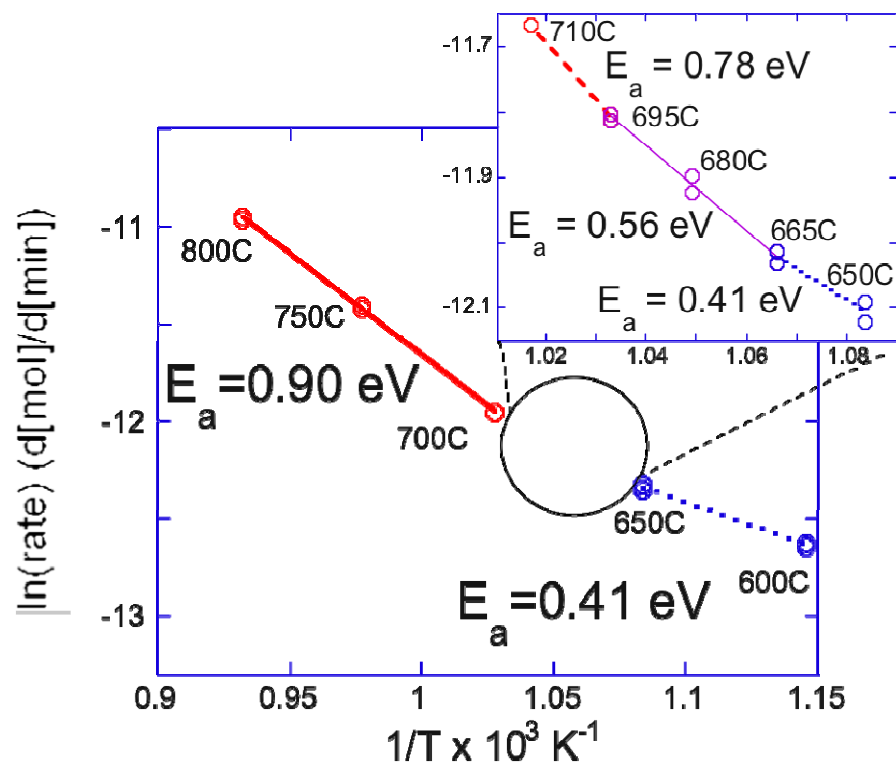
**Surface Limited Mechanism is Consistent with Fermi Level Conduction Mechanism**

[1] E. P. Murray, T. Tsai, S. A. Barnett, *Solid State Ionics* **110**, 235 (1998).

[2] S. P. Jiang, J. G. Love, Y. Ramprakash, *J. Power Sources* **110**, 201 (2002).

**Electronic Structure and Impedance are Correlated**

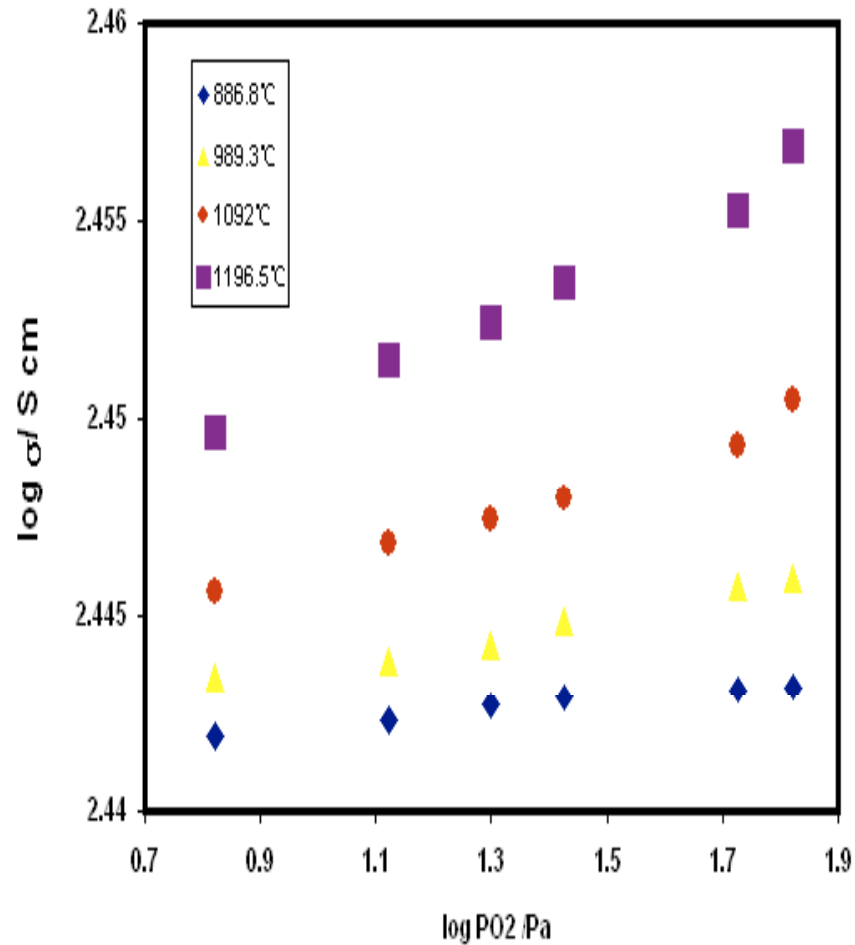
## Similar activation Energy for $^{18}\text{O}_2$ exchange for LSMO powder



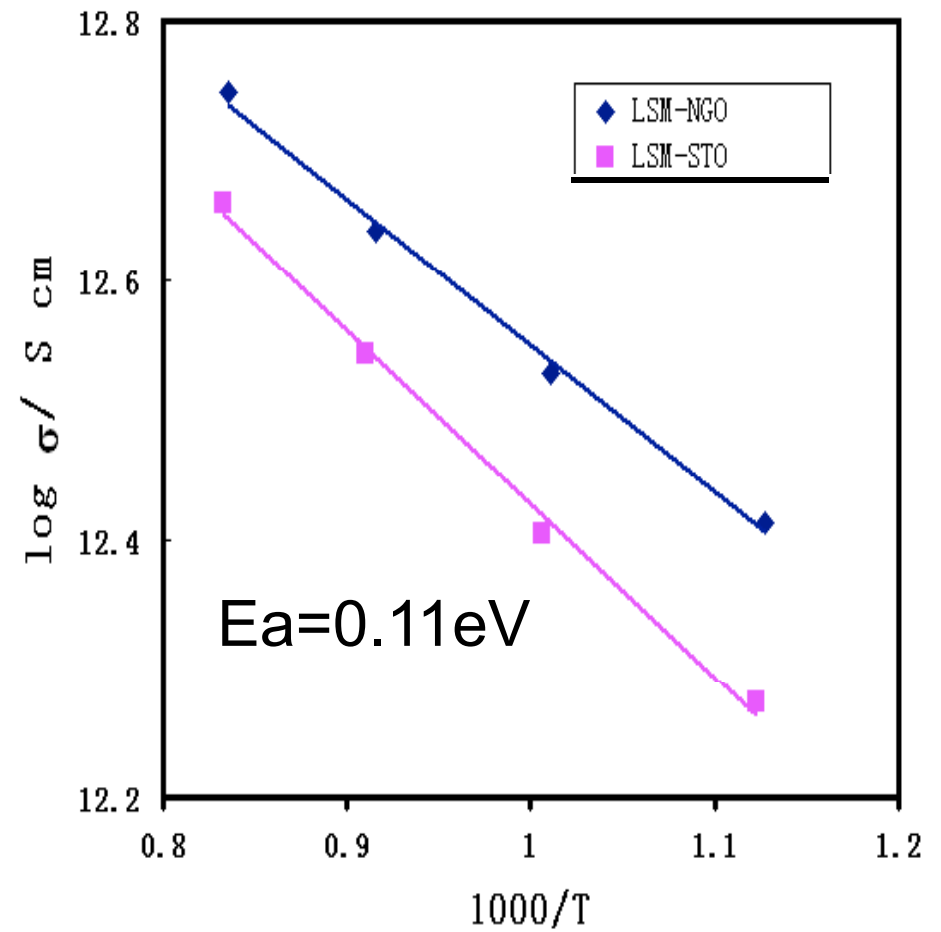
C. C Kan, H. H Kan, F. M Van Assche, E. N Armstrong, E. D Wachsman,  
*Journal of The Electrochemical Society*, **155** B985-B993 (2008).

# Affect of Substrate on Conductivity

150nm LSM(100) on NGO(100)

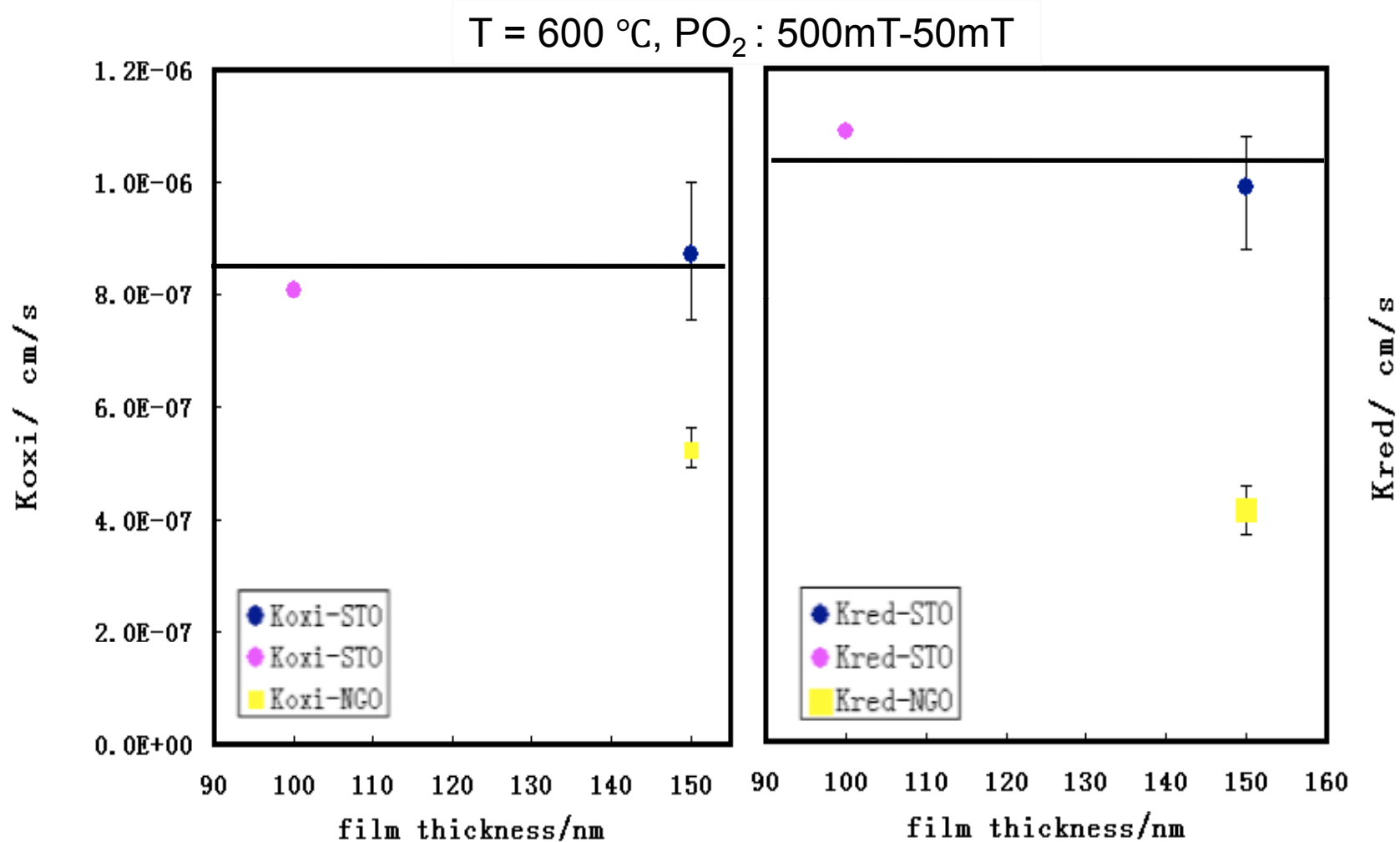


150nm LSM(100) in 500 mTorr





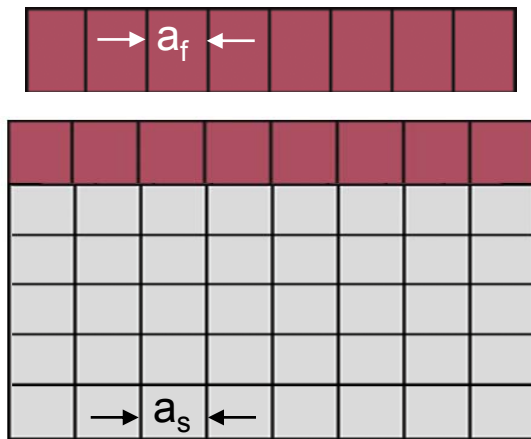
# Thickness and Substrate Dependence



# Cathode thin film growth – Substrate choice and orientation

## Mismatch Strain

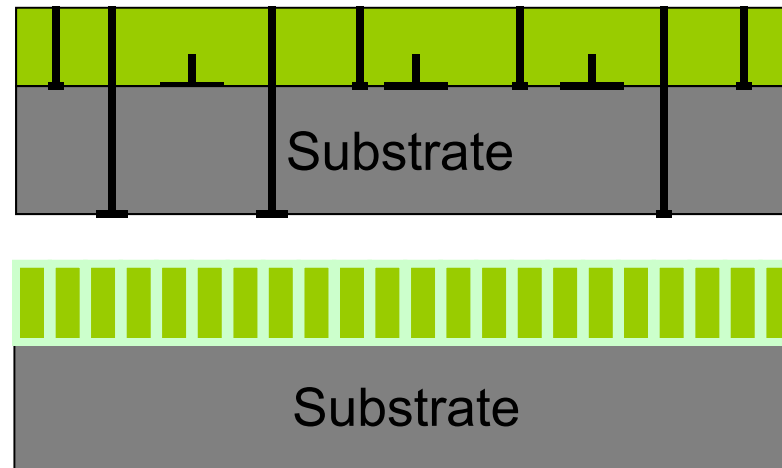
$$f = \frac{(a_s - a_f)}{a_f}$$



$$w_{strain}^{max} = \frac{2\mu(1+\nu)f^2}{(1-\nu)}$$

## Dislocations

Misfit  
Threading (relaxation)  
Threading (inherited)



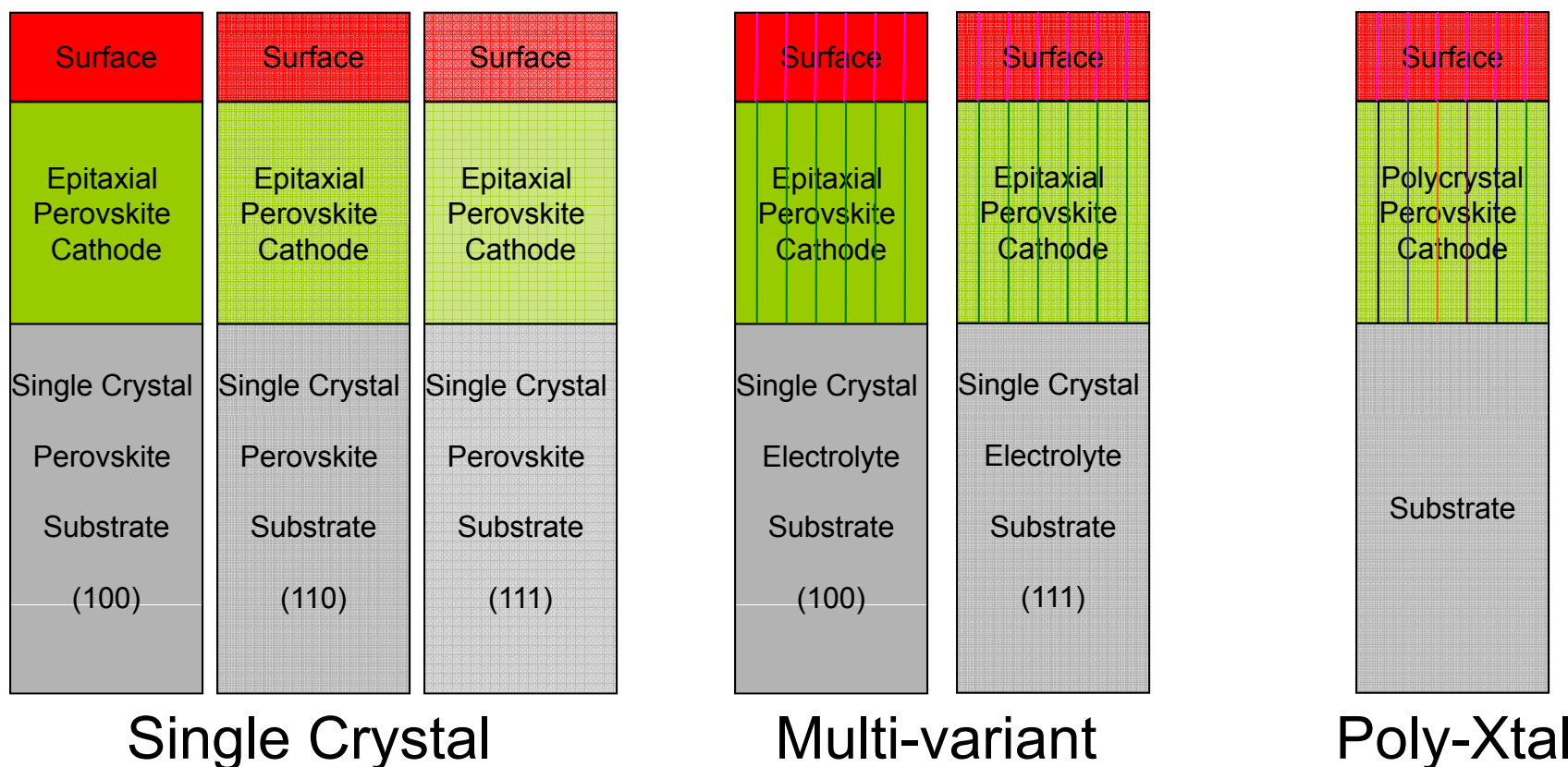
*Substrates have different lattice mismatches and  
Different dislocation densities*

# Thin Film Samples Driving Surface Science

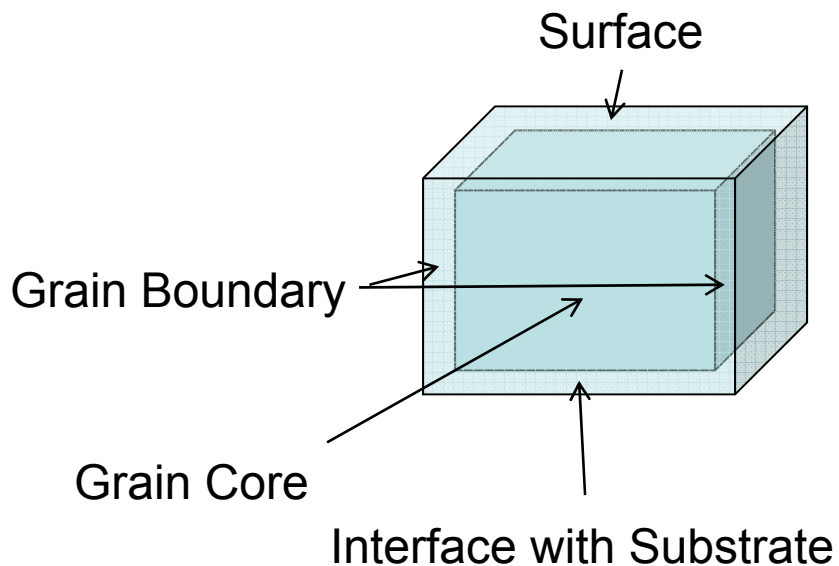
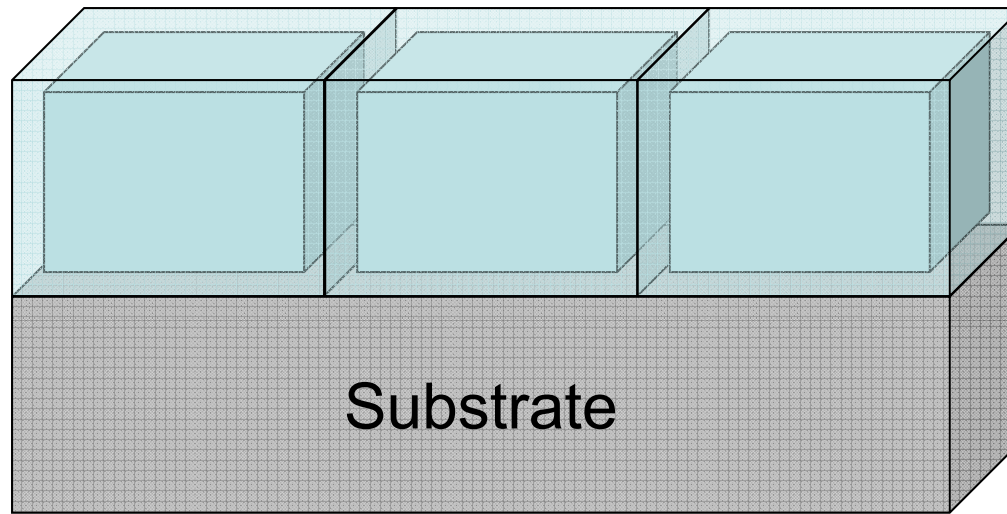
**Reaction Occurs at Surface:**



Films Allow for Surface / Microstructural Control



# Brick-Layer Type Model of Interaction

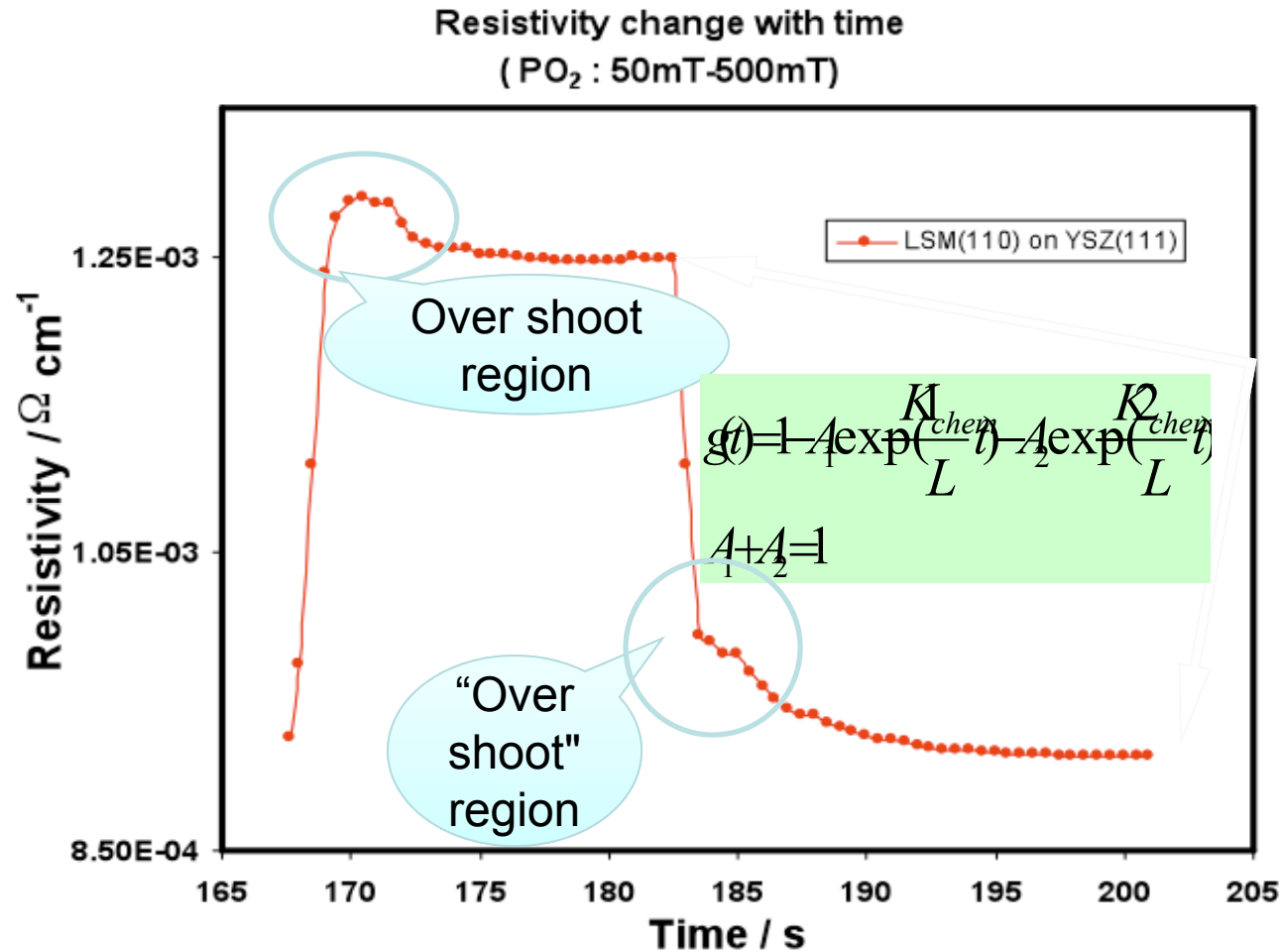


*All Films have some level of Defects*

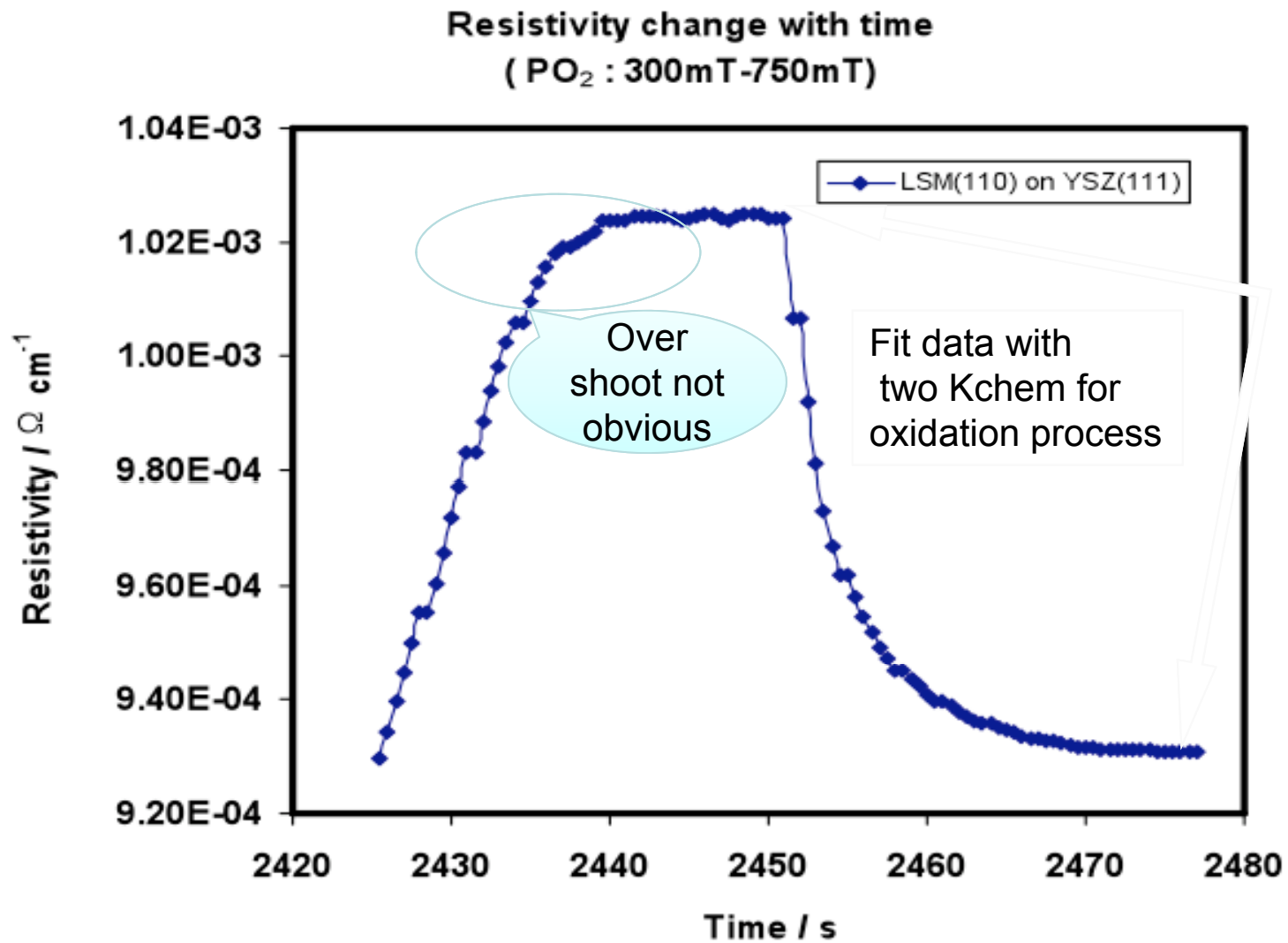
*How does the nature of the interfacial features affect performance?*

*Surface  
Grain Boundary  
Interface*

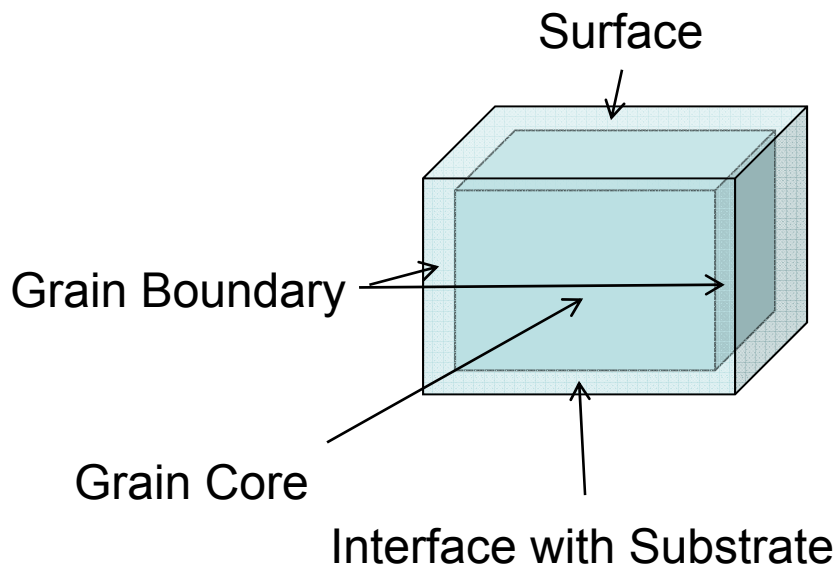
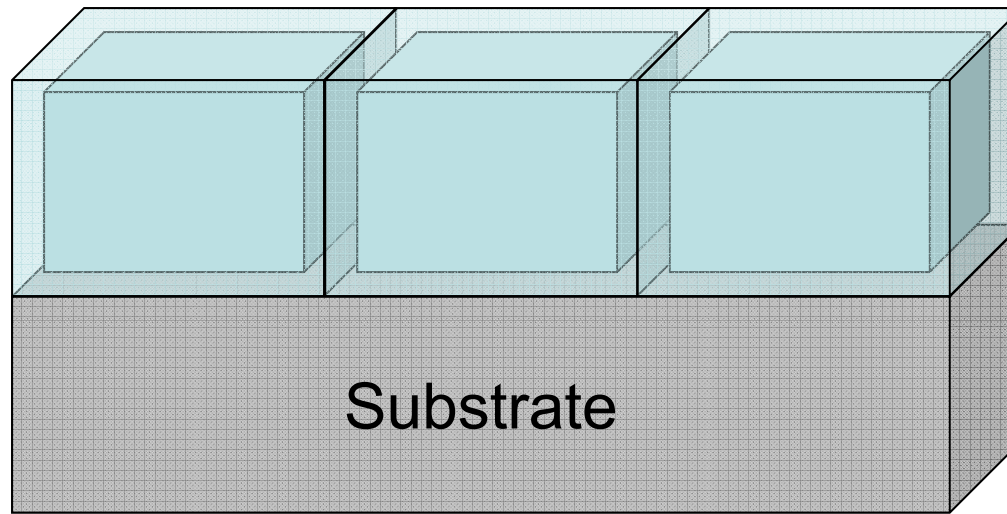
# ECR data fitting for Large Pressure Change: (110) LSM on YSZ(111)



## ECR data fitting for Small Pressure Change: (110) LSM on YSZ(111)



# Brick-Layer Type Model of Interaction



*All Films have some level of Defects*

*How does the nature of the interfacial features affect performance?*

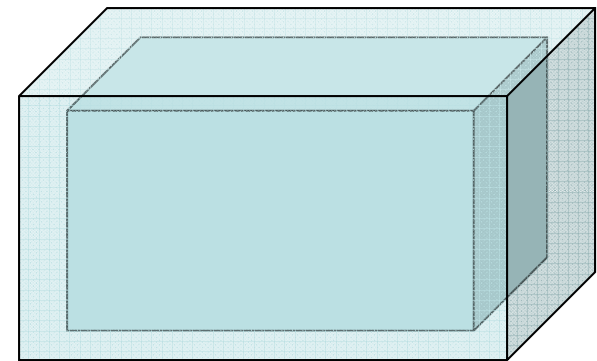
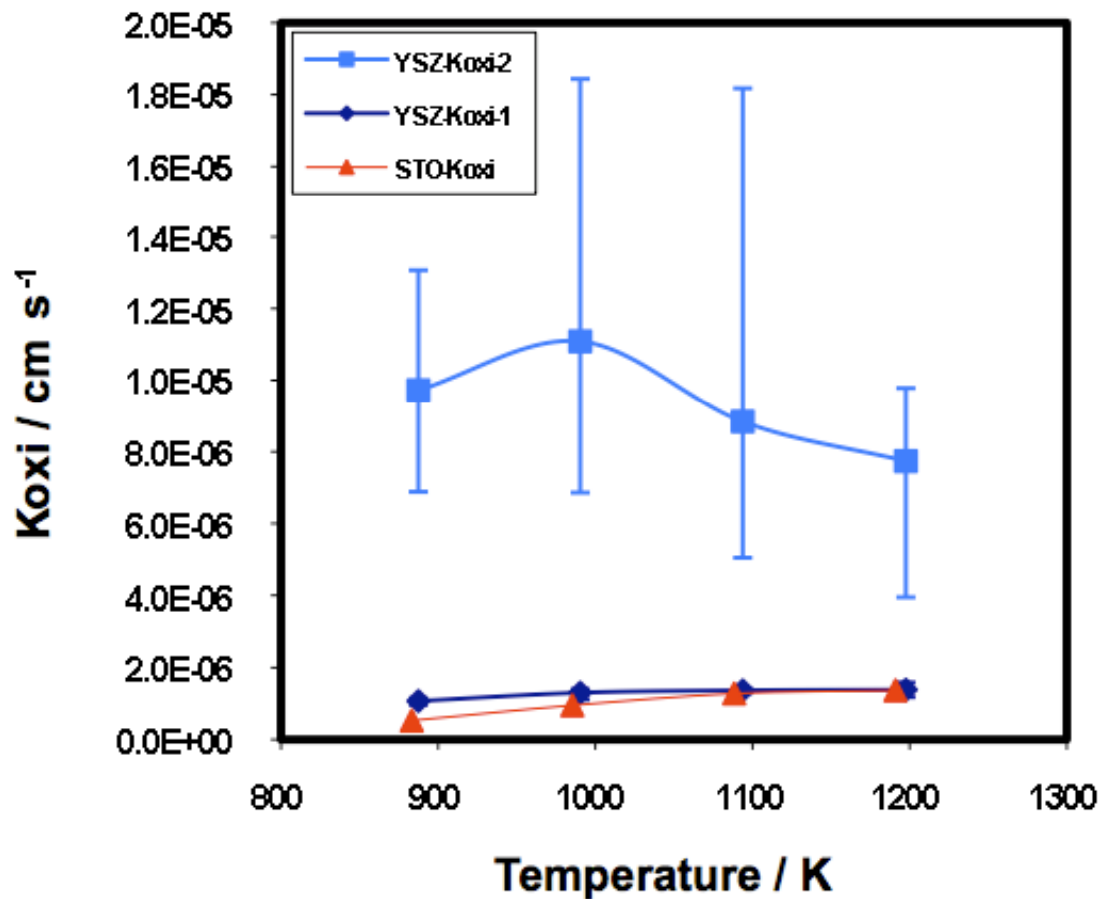
*Surface  
Grain Boundary  
Interface*



# Typical Values for Two Activation Energies

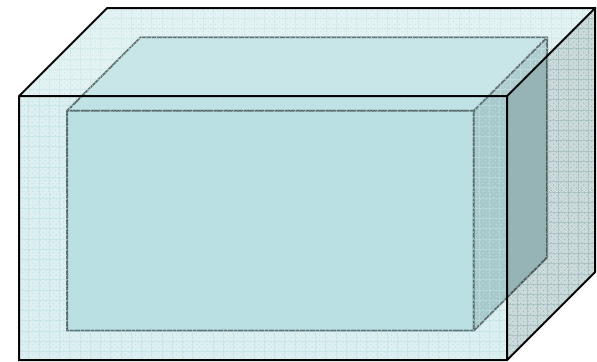
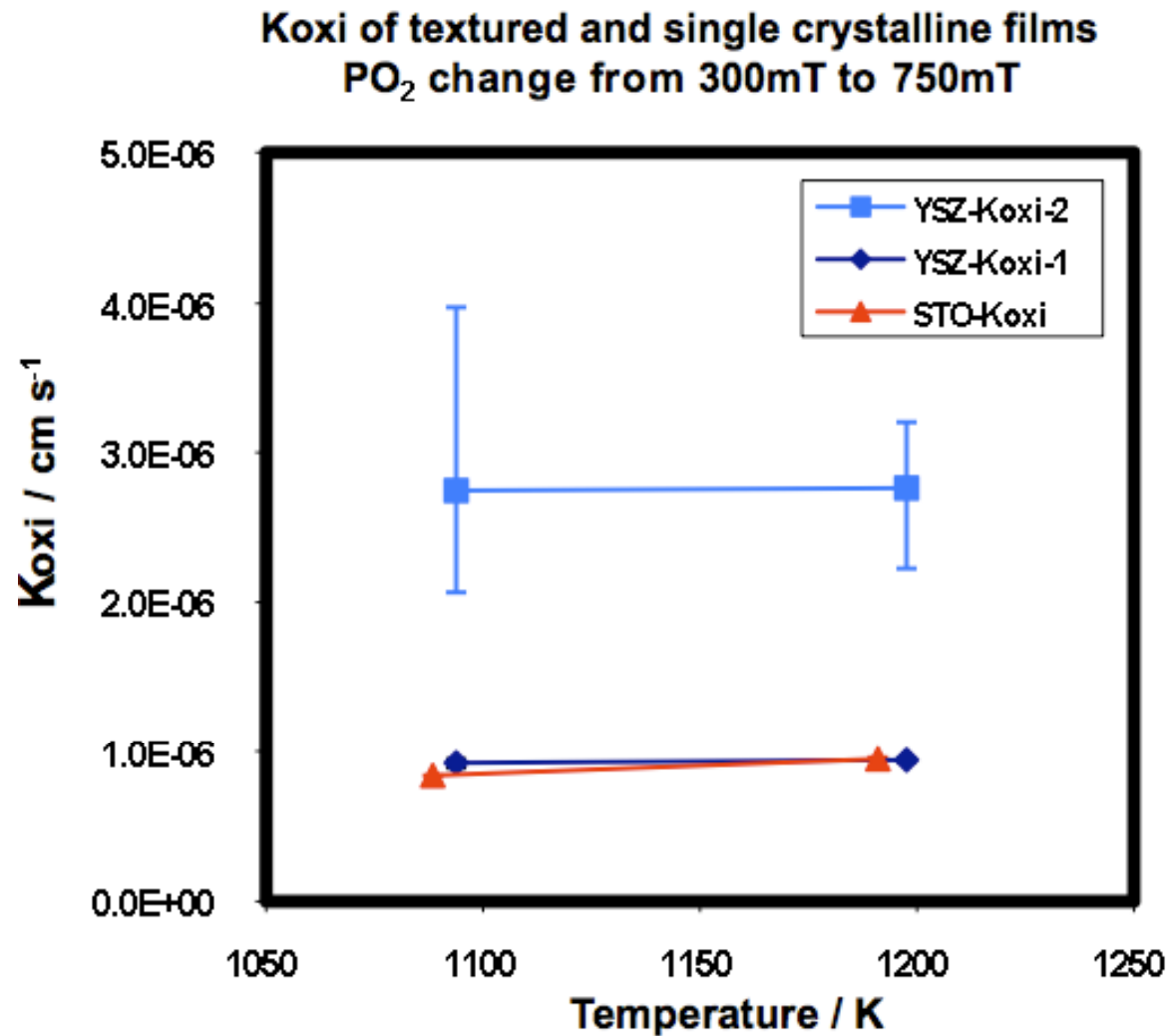
## Typical Explanation

**$K_{oxi}$  of textured and single crystalline films**  
 **$PO_2$  change from 50mT to 500mT**



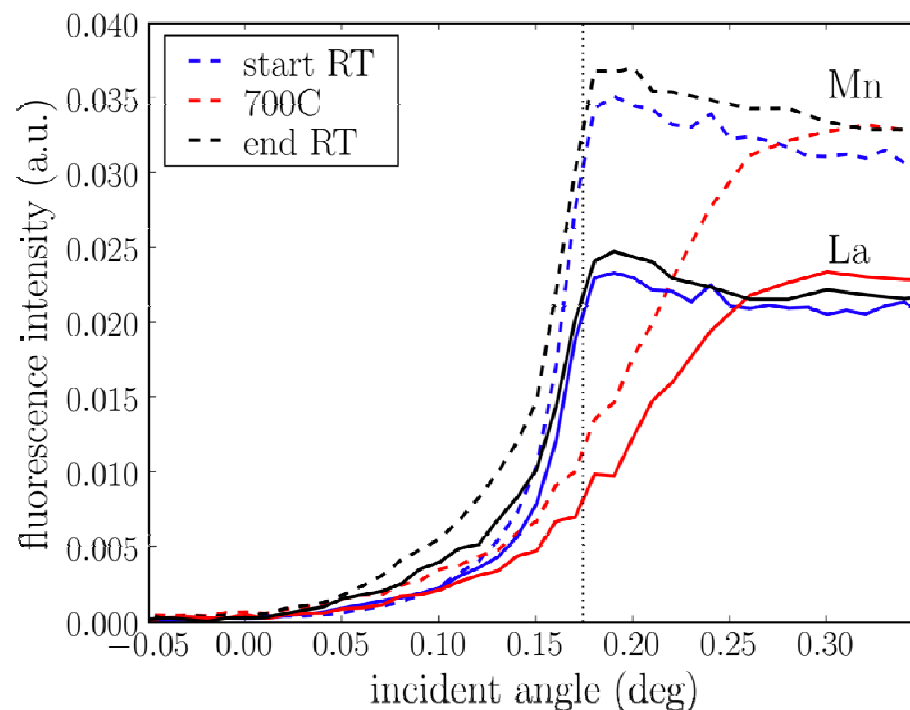
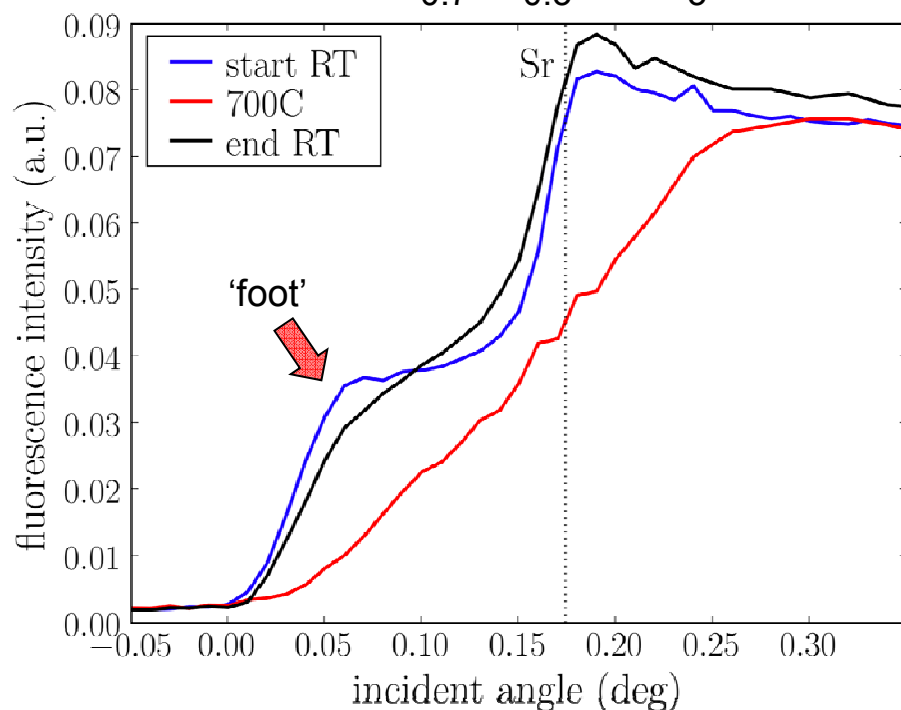
# Typical Values for Two Activation Energies

## Typical Explanation



# Temperature Dependent TXRF of LSM(110)

60 nm  $\text{La}_{0.7}\text{Sr}_{0.3}\text{MnO}_3$  on YSZ



- At room temperature, there is a 'foot' in the Sr fluorescence but not in Mn and La
- This is evidence of Sr rich particles at the LSM surface due to Sr segregation.
- This 'foot' gradually disappears at high temperature implying particles are re-incorporated.
- Process is reversible, 'foot' reappears at room temperature despite rapid cooling (700°C to room temperature in 30 minutes)

# LSMO Experimental Summary

1. Single oriented, epitaxial, smooth LSMO (100), (110) and (111) films were fabricated on STO and LSMO (100) on NGO.
1. Multivariant epitaxial LSMO (100) and (110) were fabricated on YSZ(100)/GDC(100) and YSZ(111)
3. Steady-state conductivity measurements on LSMO films exhibit consistent results as reported in literatures.
4. Transient conductivity measurements proved that surface anisotropy plays a role in the oxygen exchange process:  
at high T:  $K_{\text{chem}}(111) > K_{\text{chem}}(100) > K_{\text{chem}}(110)$   
at low T:  $K_{\text{chem}}(100) > K_{\text{chem}}(111) > K_{\text{chem}}(110)$   
 $K_{\text{chem}}(\text{reduction}) > \approx K_{\text{chem}}(\text{oxidation})$ .
5. Values on NGO are slightly lower than on STO.
6. Microstructure is observed to play a role on thin films...

# CMU Work for Cathode Surface Science Project

- *Growth of High-Quality Thin Film Samples*
  - *Perovskite / Perovskite Epitaxy and Surface Control*
  - *Perovskite / Fluorite Epitaxy and Surface Control*
  - *Generation of Surface-Modified Samples*
- *Surface Kinetics for Oxygen Uptake*
  - *Electrical Conductivity Relaxation*
  - *Piezoelectric Crystal Microbalance Gravimetry*
  - *Kelvin Probe Spectroscopy*
- *Surface Thermodynamics of Oxygen Uptake*
  - *Piezoelectric Crystal Microbalance Gravimetry*
  - *Kelvin Probe Spectroscopy*
- *Electronic Structure*
  - *Kelvin Probe Spectroscopy*
  - *STM (MIT)*
- *Ex-situ Surface Characterization for Correlations*
  - *Scanning Auger / XPS*